

LOC	OBJECT CODE	ADDR1	ADDR2	STMT
2				*****
3	*			
4	*			Zvector E6 instruction tests for VRR-b encoded:
5	*			
6	*			E674 VSCHP - DECIMAL SCALE AND CONVERT TO HFP
7	*			
8	*			James Wekel June 2024
9				*****
11				*****
12	*			
13	*			basic instruction tests
14	*			
15				*****
16	*			This program tests proper functioning of the z/arch E6 VRR-b decimal
17	*			scale and convert to HFP instruction. Exceptions are not tested.
18	*			
19	*			PLEASE NOTE that the tests are very SIMPLE TESTS designed to catch
20	*			obvious coding errors. None of the tests are thorough. They are
21	*			NOT designed to test all aspects of any of the instructions.
22	*			
23				*****
24	*			
25	*			A cross-check test is performed if the rounding mode is zero,
26	*			and the shifted packed decimal source can be converted to a 64-bit
27	*			fixed value without overflow. The cross-check test converts the
28	*			packed decimal source, uses CEGR, CDGR or CXGR to convert to
29	*			HFP. This result is compared to VSCHP result. An XCHECK test
30	*			error message will be issued if there is a difference.
31	*			
32				*****
33	*			
34	*			*Testcase zvector-e6-17-VSCHP: VECTOR E6 VRR-b VSCHP instruction
35	*			
36	*			Zvector E6 instruction tests for VRR-b encoded:
37	*			
38	*			E674 VSCHP - DECIMAL SCALE AND CONVERT TO HFP
39	*			
40	*			# -----
41	*			# This tests only the basic function of the instruction.
42	*			# Exceptions are NOT tested.
43	*			# -----
44	*			
45	*	mainsize	2	
46	*	numcpu	1	
47	*	sysclear		
48	*	archlvl	z/Arch	
49	*			
50	*	loadcore	\$(testpath)/zvector-e6-17-VSCHP.core	0x0
51	*			
52	*	diag8cmd	enable	# (needed for messages to Hercules console)
53	*	runtest	2	
54	*	diag8cmd	disable	# (reset back to default)
55	*			
56	*			*Done

LOC	OBJECT CODE	ADDR1	ADDR2	STMT
60				*****
61	*			FCHECK Macro - Is a Facility Bit set?
62	*			
63	*			If the facility bit is NOT set, an message is issued and
64	*			the test is skipped.
65	*			
66	*			Fcheck uses R0, R1 and R2
67	*			
68	* eg.			FCHECK 134, 'vector-packed-decimal'
69				*****
70				MACRO
71				FCHECK &BITNO, &NOTSETMSG
72	. *			&BITNO : facility bit number to check
73	. *			&NOTSETMSG : 'facility name'
74	LCLA	&FBBYTE		Facility bit in Byte
75	LCLA	&FBBIT		Facility bit within Byte
76				
77	LCLA	&L(8)		
78	&L(1)	SetA	128, 64, 32, 16, 8, 4, 2, 1	bit positions within byte
79				
80	&FBBYTE	SETA	&BITNO/8	
81	&FBBIT	SETA	&L((&BITNO-(&FBBYTE*8))+1)	
82	. *	MNOTE	0, 'checking Bit=&BITNO: FBBYTE=&FBBYTE, FBBIT=&FBBIT'	
83				
84	B	X&SYSNDX		
85	*			Fcheck data area
86	*			skip message
87	SKT&SYSNDX DC	C'		Skipping tests:
88	DC	C&NOTSETMSG		
89	DC	C'		facility (bit &BITNO) is not installed.'
90	SKL&SYSNDX EQU	*- SKT&SYSNDX		
91	*			facility bits
92	DS	FD		gap
93	FB&SYSNDX DS	4FD		
94	DS	FD		gap
95	*			
96	X&SYSNDX EQU	*		
97	LA	R0, ((X&SYSNDX- FB&SYSNDX)/8)-1		
98	STFLE	FB&SYSNDX		get facility bits
99				
100	XGR	R0, R0		
101	IC	R0, FB&SYSNDX+&FBBYTE		get fbit byte
102	N	R0, =F' &FBBIT'		is bit set?
103	BNZ	XC&SYSNDX		
104	*			
105	*			facility bit not set, issue message and exit
106	*			
107	LA	R0, SKL&SYSNDX		message length
108	LA	R1, SKT&SYSNDX		message address
109	BAL	R2, MSG		
110				
111	B	EOJ		
112	XC&SYSNDX EQU	*		
113		MEND		

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
				115 ****		
				116 *	Low core PSWs	
				117 ****		
00000000	00000000 00003A17	00000000	00000000	119 ZVE6TST START 0 120 USING ZVE6TST, R0	Low core addressability	
				121		
	00000140	00000000	00000000	122 SVOLDPSW EQU ZVE6TST+X'140'	z/Arch Supervisor call old PSW	
00000000	00000000 000001A0	00000000 00000001	80000000	124 ORG ZVE6TST+X'1A0'	z/Architecture RESTART PSW	
000001A0	00000001 80000000			125 DC X'0000000180000000'		
000001A8	00000000 00000200			126 DC AD(BEGIN)		
000001B0	000001B0 000001D0	000001B0	000001D0	128 ORG ZVE6TST+X'1D0'	z/Architecture PROGRAM CHECK PSW	
000001D0	00020001 80000000			129 DC X'0002000180000000'		
000001D8	00000000 0000DEAD			130 DC AD(X' DEAD')		
000001E0	000001E0 00000200	000001E0	00000200	132 ORG ZVE6TST+X'200'	Start of actual test program..	

LOC	OBJECT CODE	ADDR1	ADDR2	STMT
				134 135 ****= 136 * The actual "ZVE6TST" program itself... 137 ****= 138 *
				139 * Architecture Mode: z/Arch 140 * Register Usage: 141 *
				142 * R0 (work) 143 * R1-4 (work) 144 * R5 Testing control table - current test base 145 * R6-R7 (work) 146 * R8 First base register 147 * R9 Second base register 148 * R10 Third base register 149 * R11 E6TEST call return 150 * R12 E6TESTS register 151 * R13 (work) 152 * R14 Subroutine call 153 * R15 Secondary Subroutine call or work 154 * 155 ****=
00000200		00000200		157 USING BEGIN, R8 FIRST Base Register
00000200		00001200		158 USING BEGIN+4096, R9 SECOND Base Register
00000200		00002200		159 USING BEGIN+8192, R10 THIRD Base Register 160
00000200	0580			161 BEGIN BALR R8, 0 Initialize FIRST base register
00000202	0680			162 BCTR R8, 0 Initialize FIRST base register
00000204	0680			163 BCTR R8, 0 Initialize FIRST base register 164
00000206	4190 8800		00000800	165 LA R9, 2048(, R8) Initialize SECOND base register
0000020A	4190 9800		00000800	166 LA R9, 2048(, R9) Initialize SECOND base register 167
0000020E	41A0 9800		00000800	168 LA R10, 2048(, R9) Initialize THIRD base register
00000212	41A0 A800		00000800	169 LA R10, 2048(, R10) Initialize THIRD base register 170
00000216	B600 8444		00000644	171 STCTL R0, R0, CTLR0 Store CRO to enable AFP
0000021A	9604 8445		00000645	172 OI CTLR0+1, X'04' Turn on AFP bit
0000021E	9602 8445		00000645	173 OI CTLR0+1, X'02' Turn on Vector bit
00000222	B700 8444		00000644	174 LCTL R0, R0, CTLR0 Reload updated CRO 175
				176 ****= 177 * Is Vector-packed-decimal-enhancement facility 2 installed (bit 192) 178 ****=
				179
00000226	47F0 80C8		000002C8	180 FCHECK 192, 'vector-packed-decimal-enhancement facility 2' 181+ B X0001 Fcheck data area 182+* skip message 183+*
0000022A	40404040 40404040			184+SKT0001 DC C' Skipping tests: '
00000244	A58583A3 96996097			185+ DC C' vector-packed-decimal-enhancement facility 2'
00000270	40868183 899389A3			186+ DC C' facility (bit 192) is not installed.'
		0000006B	00000001	187+SKL0001 EQU *-SKT0001
				188+* DS FD facility bits 189+ gap
00000298	00000000 00000000			

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
000002A0	00000000 00000000			190+FB0001	DS	4FD	
000002C0	00000000 00000000			191+	DS	FD	gap
				192+*			
000002C8	4100 0004	000002C8	00000001	193+X0001	EQU	*	
000002CC	B2B0 80A0		00000004	194+	LA	RO, ((X0001-FB0001)/8)-1	
000002D0	B982 0000		000002A0	195+	STFLE	FB0001	get facility bits
000002D4	4300 80B8			196+	XGR	RO, RO	
000002D8	5400 844C		000002B8	197+	IC	RO, FB0001+24	get fbit byte
000002DC	4770 80F0		0000064C	198+	N	RO, =F'128'	is bit set?
			000002F0	199+	BNZ	XC0001	
				200+*			
				201+*	facility bit not set, issue message and exit		
				202+*			
000002E0	4100 006B		0000006B	203+	LA	RO, SKL0001	message length
000002E4	4110 802A		0000022A	204+	LA	R1, SKT0001	message address
000002E8	4520 8360		00000560	205+	BAL	R2, MSG	
000002EC	47F0 8428		00000628	206+	B	EOJ	
		000002F0	00000001	207+XC0001	EQU	*	
				208			

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
				210 ****			
				211 *			
				Do tests in the E6TESTS table			
				212 ****			
000002F0	58C0 8450		00000650	214 L R12, =A(E6TESTS)		get table of test addresses	
				215			
000002F4	5850 C000	000002F4	00000001	216 NEXTE6 EQU *		get test address	
000002F8	1255		00000000	217 L R5, 0(0, R12)		have a test?	
000002FA	4780 8316		00000516	218 LTR R5, R5			
				219 BZ ENDTEST		done?	
				220			
000002FE		00000000		221 USING E6TEST, R5			
				222			
000002FE	4800 5004		00000004	223 LH R0, TNUM		save current test number	
00000302	5000 8E04		00001004	224 ST R0, TESTING		for easy reference	
00000306	58B0 5000		00000000	225 L R11, TSUB		get address of test routine	
0000030A	05BB			226 BALR R11, R11		do test	
0000030C	E710 8F0C 000E		0000110C	227 VST V1, V1OUTPUT		save result	
00000312	45F0 812E		0000032E	228			
				229 BAL R15, XCHECK			
				230			
00000316	E310 501C 0014		0000001C	231 LGF R1, READDR		expected result address	
0000031C	D50F 8F0C 1000	0000110C	00000000	232 CLC V1OUTPUT, 0(R1)			
00000322	4770 8280		00000480	233 BNE FAILMSG		no, issue failed message	
				234			
00000326	41C0 C004		00000004	235			
0000032A	47F0 80F4		000002F4	236 LA R12, 4(0, R12)		next test address	
				237 B NEXTE6			
				238			

LOC	OBJECT CODE	ADDR1	ADDR2	STMT
				240 *-----
				241 * For small (19 digit) values, cross check result
				242 * if rounding mode = 0 and conversion to 64-bit does not overflow
				243 *
				244 * R15 - RETURN
				245 *
				246 * v1, v2, v3 have result, source, scale
				247 *-----
		0000032E	00000001	248 XCHECK EQU *
				249
0000032E	B982 0011			250 XGR R1, R1 Is Rounding Mode = 0?
00000332	4310 5008		00000008	251 IC R1, M5 get M5
00000336	A517 0001			252 NILL r1, 1 RM : bit 3
0000033A	1211			253 LTR R1, R1
0000033C	477F 0000		00000000	254 BNZ 0(R15) not zero RM ignore test
				255
00000340	E7B2 0000 0056			256 VLR V11, V2 copy source
00000346	E6AB 3019 F072			257 VSRPR V10, V11, V3, 159, 1 shift
0000034C	071F			258 BCR 1, R15 cc=3: overflow: ignore and return
				259
0000034E	E60A 0018 0052			260 VCVBG R0, V10, 1, 8 get 64-bit binary value
00000354	071F			261 BCR 1, 15 cc=3: overflow: ignore and return
				262
00000356	E640 8454 2004	00000654		263 VLLEBRZ V4, =F' 0' , 2 zero V4 (FPR4)
0000035C	E660 8454 2004	00000654		264 VLLEBRZ V6, =F' 0' , 2 zero V6 (FPR6)
				265 *
				266 * convert R0 to appropriate HFP format
				267 * m4: 2-> short, 3->long, 4->extended
				268 *
00000362	B982 0011			269 XGR R1, R1
00000366	4310 5007		00000007	270 IC R1, M4 get hfp format
0000036A	5910 8458		00000658	271 C R1, =F' 2'
0000036E	4780 8184		00000384	272 BE XCSHORT
00000372	5910 845C		0000065C	273 C R1, =F' 3'
00000376	4780 8194		00000394	274 BE XCLONG
0000037A	5910 8460		00000660	275 C R1, =F' 4'
0000037E	4780 81A4		000003A4	276 BE XCEXT
00000382	07FF			277 BR R15 invalid format: ignore
				278
00000384				279 * hfp - short
00000384	B3C4 0040			280 XCSHORT DS OF
00000388	E740 8258 000E	00000458		281 CEGR FPR4, R0 convert r0 to short hfp
0000038E	47F0 81B4	000003B4		282 VST V4, XCRESULT
				283 B XC001
				284
00000394				285 * hfp - long
00000394	B3C5 0040			286 XCLONG DS OF
00000398	E740 8258 000E	00000458		287 CDGR FPR4, R0 convert r0 to long hfp
0000039E	47F0 81B4	000003B4		288 VST V4, XCRESULT
				289 B XC001
				290
000003A4				291 * hfp - extended
000003A4	B3C6 0040			292 XCEXT DS OF
000003A8	E740 8258 000A	00000458		293 CXGR FPR4, R0 convert r0 to extended hfp: FPR4 & FPR6
000003AE	E760 8260 000A	00000460	294	VSTEG V4, XCRESULT, 0 save high order extended hfp
			295	VSTEG V6, XCRESULT+8, 0 save low order extended hfp

LOC	OBJECT CODE	ADDR1	ADDR2	STMT				
				296				
000003B4	E710 8268 000E	000003B4	00000001	297 XC001	EQU *	VST	V1, XCV1	
000003BA	D50F 8268 8258	00000468	00000458	298		CLC	XCV1, XCRESULT	
000003C0	478F 0000		00000000	299 300	BE 0(R15)		ok, exit	
				301				
				302	* xcheck failed message			
				303				
000003C4	4820 5004		00000004	304	LH	R2, TNUM	get test number and convert	
000003C8	4E20 8EEB		000010EB	305	CVD	R2, DECNUM		
000003CC	D211 8ED5 8EBF	000010D5	000010BF	306	MVC	PRT3, EDIT		
000003D2	DE11 8ED5 8EEB	000010D5	000010EB	307	ED	PRT3, DECNUM		
000003D8	D202 8E6D 8EE2	0000106D	000010E2	308	MVC	XCPTNUM(3), PRT3+13	fill in message with test #	
				309				
000003DE	D207 8E8F 5010	0000108F	00000010	310	MVC	XCPNAME, OPNAME	fill in message with instruction	
				311				
000003E4	B982 0022			312	XGR	R2, R2	get m4 as U8	
000003E8	4320 5007		00000007	313	IC	R2, M4		
000003EC	4E20 8EEB		000010EB	314	CVD	R2, DECNUM	and convert	
000003F0	D211 8ED5 8EBF	000010D5	000010BF	315	MVC	PRT3, EDIT		
000003F6	DE11 8ED5 8EEB	000010D5	000010EB	316	ED	PRT3, DECNUM		
000003FC	D201 8EA0 8EE3	000010A0	000010E3	317	MVC	XCPM(2), PRT3+14	fill in message with m4 field	
				318				
00000402	B982 0022			319	XGR	R2, R2	get m5 as U8	
00000406	4320 5008		00000008	320	IC	R2, M5		
0000040A	4E20 8EEB		000010EB	321	CVD	R2, DECNUM	and convert	
0000040E	D211 8ED5 8EBF	000010D5	000010BF	322	MVC	PRT3, EDIT		
00000414	DE11 8ED5 8EEB	000010D5	000010EB	323	ED	PRT3, DECNUM		
0000041A	D201 8EAC 8EE3	000010AC	000010E3	324	MVC	XCPM(2), PRT3+14	fill in message with m5 field	
				325				
00000420	B982 0022			326	XGR	R2, R2	get scale as U8	
00000424	4320 5009		00000009	327	IC	R2, SCALE	and convert	
00000428	4E20 8EEB		000010EB	328	CVD	R2, DECNUM		
0000042C	D211 8ED5 8EBF	000010D5	000010BF	329	MVC	PRT3, EDIT		
00000432	DE11 8ED5 8EEB	000010D5	000010EB	330	ED	PRT3, DECNUM		
00000438	D202 8EBB 8EE2	000010BB	000010E2	331	MVC	XCPSCALE(3), PRT3+13	fill in message with scale field	
				332				
0000043E	50F0 8278		00000478	333	ST	R15, XCR15	save r15	
00000442	4100 005F		0000005F	334	LA	R0, XCPLNG	message length	
00000446	4110 8E60		00001060	335	LA	R1, XCPLINE	message address	
0000044A	45F0 8324		00000524	336	BAL	R15, RPERROR		
				337				
0000044E	58F0 8278		00000478	338	L	R15, XCR15		
00000452	07FF			339	BR	R15	return from xcheck	
				340				
00000458	00000000 00000000			341	DS	OFD		
00000458	00000000 00000000			342	XCRESULT	DS XL16		
00000468	00000000 00000000			343	XCV1	ds XL16		
00000478	00000000 00000000			344	XCR15	DS FD		
				345				

LOC	OBJECT CODE	ADDR1	ADDR2	STMT				
				347 ****				
				348 * result not as expected:				
				349 * issue message with test number, instruction under test				
				350 * and instruction m4, m5				
				351 ****				
00000480	4820 5004	00000480	00000001	352 FAILMSG EQU *				
00000484	4E20 8EEB		00000004	353 LH R2, TNUM				get test number and convert
00000488	D211 8ED5 8EBF	000010D5	000010BF	354 CVD R2, DECNUM				
0000048E	DE11 8ED5 8EEB	000010D5	000010EB	355 MVC PRT3, EDIT				
00000494	D202 8E15 8EE2	00001015	000010E2	356 ED PRT3, DECNUM				
				357 MVC PRTNUM(3), PRT3+13				fill in message with test #
0000049A	D207 8E30 5010	00001030	00000010	358				
				359 MVC PRTNAME, OPNAME				fill in message with instruction
				360 *				
000004A0	B982 0022			361 XGR R2, R2				
000004A4	4320 5007		00000007	362 IC R2, M4				get m4 and convert
000004A8	4E20 8EEB		000010EB	363 CVD R2, DECNUM				
000004AC	D211 8ED5 8EBF	000010D5	000010BF	364 MVC PRT3, EDIT				
000004B2	DE11 8ED5 8EEB	000010D5	000010EB	365 ED PRT3, DECNUM				
000004B8	D201 8E41 8EE3	00001041	000010E3	366 MVC PRTM4(2), PRT3+14				fill in message with m4 field
				367 *				
000004BE	B982 0022			368 XGR R2, R2				
000004C2	4320 5008		00000008	369 IC R2, M5				get m5 and convert
000004C6	4E20 8EEB		000010EB	370 CVD R2, DECNUM				
000004CA	D211 8ED5 8EBF	000010D5	000010BF	371 MVC PRT3, EDIT				
000004D0	DE11 8ED5 8EEB	000010D5	000010EB	372 ED PRT3, DECNUM				
000004D6	D201 8E4D 8EE3	0000104D	000010E3	373 MVC PRTM5(2), PRT3+14				fill in message with m5 field
				374 *				
000004DC	B982 0022			375 XGR R2, R2				
000004E0	4320 5009		00000009	376 IC R2, SCALE				get scale and convert
000004E4	4E20 8EEB		000010EB	377 CVD R2, DECNUM				
000004E8	D211 8ED5 8EBF	000010D5	000010BF	378 MVC PRT3, EDIT				
000004EE	DE11 8ED5 8EEB	000010D5	000010EB	379 ED PRT3, DECNUM				
000004F4	D202 8E5C 8EE2	0000105C	000010E2	380 MVC PRTSCALE(3), PRT3+13				fill in message with scale
				381				
000004FA	4100 0058		00000058	382 LA R0, PRTLNG				message length
000004FE	4110 8E08		00001008	383 LA R1, PRTLINE				message address
00000502	45F0 8324		00000524	384 BAL R15, RPERROR				
				386 ****				
				387 * continue after a failed test				
				388 ****				
		00000506	00000001	389 FAILCONT EQU *				
00000506	5800 8464		00000664	390 L R0, =F' 1'				set failed test indicator
0000050A	5000 8E00		00001000	391 ST R0, FAILED				
				392				
0000050E	41C0 C004		00000004	393 LA R12, 4(0, R12)				next test address
00000512	47F0 80F4		000002F4	394 B NEXTE6				
				396 ****				
				397 * end of testing; set ending psw				
				398 ****				
00000516	5810 8E00	00000516	00000001	399 ENDTEST EQU *				
			00001000	400 L R1, FAILED				did a test fail?

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
0000051A	1211		401	LTR	R1, R1		
0000051C	4780 8428	00000628	402	BZ	EOJ	No, exit	
00000520	47F0 8440	00000640	403 404	B	FAILTEST	Yes, exit with BAD PSW	

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
				406 ****	*****	*****
				407 * RPTERROR	Report instruction test in error	
				408 *	R0 = MESSGAE LENGTH	
				409 *	R1 = ADDRESS OF MESSAGE	
				410 ****	*****	*****
00000524	50F0 8344	00000544	412	RPTERROR ST	R15, RPTSAVE	Save return address
00000528	5050 8348	00000548	413	ST	R5, RPTSVR5	Save R5
			414 *			
			415 *	Use Hercules Diagnose for Message to console		
			416 *			
0000052C	9002 8350	00000550	417	STM	R0, R2, RPTDWSAV	save regs used by MSG
00000530	4520 8360	00000560	418	BAL	R2, MSG	call Hercules console MSG display
00000534	9802 8350	00000550	419	LM	R0, R2, RPTDWSAV	restore regs
00000538	5850 8348	00000548	421	L	R5, RPTSVR5	Restore R5
0000053C	58F0 8344	00000544	422	L	R15, RPTSAVE	Restore return address
00000540	07FF		423	BR	R15	Return to caller
00000544	00000000		425	RPTSAVE DC	F' 0'	R15 save area
00000548	00000000		426	RPTSVR5 DC	F' 0'	R5 save area
00000550	00000000 00000000		428	RPTDWSAV DC	2D' 0'	R0-R2 save area for MSG call

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
				430 **** 431 * Issue HERCULES MESSAGE pointed to by R1, length in R0 432 * R2 = return address 433 ****			
00000560	4900 8468		00000668	435 MSG CH R0, =H' 0' 436 BNHR R2		Do we even HAVE a message? No, ignore	
00000564	07D2						
00000566	9002 839C		0000059C	438 STM R0, R2, MSGSAVE		Save registers	
0000056A	4900 846A		0000066A	440 CH R0, =AL2(L' MSGMSG)		Message length within limits?	
0000056E	47D0 8376		00000576	441 BNH MSGOK		Yes, continue	
00000572	4100 005F		0000005F	442 LA R0, L' MSGMSG		No, set to maximum	
00000576	1820		000005A8	444 MSGOK LR R2, R0 445 BCTR R2, 0 446 EX R2, MSGMVC		Copy length to work register Minus-1 for execute Copy message to O/P buffer	
00000578	0620						
0000057A	4420 83A8						
0000057E	4120 200A		0000000A	448 LA R2, 1+L' MSGCMD(, R2)		Calculate true command length	
00000582	4110 83AE		000005AE	449 LA R1, MSGCMD		Point to true command	
00000586	83120008		00000596	451 DC X' 83' , X' 12' , X' 0008'		Issue Hercules Diagnose X' 008'	
0000058A	4780 8396			452 BZ MSGRET		Return if successful	
0000058E	1222		00000596	453 454 LTR R2, R2 455 BZ MSGRET 456 457 DC H' 0'		Is Diag8 Ry (R2) 0? an error occurred but continue	
00000590	4780 8396						
00000594	0000					CRASH for debugging purposes	
00000596	9802 839C		0000059C	459 MSGRET LM R0, R2, MSGSAVE 460 BR R2		Restore registers Return to caller	
0000059A	07F2						
0000059C	00000000 00000000		000005B7	462 MSGSAVE DC 3F' 0'		Registers save area	
000005A8	D200 83B7 1000	00000000		463 MSGMVC MVC MSGMSG(0), 0(R1)		Executed instruction	
000005AE	D4E2C7D5 D6C8405C			465 MSGCMD DC C' MSGNOH * '		*** HERCULES MESSAGE COMMAND ***	
000005B7	40404040 40404040			466 MSGMSG DC CL95' '		The message text to be displayed	
467							

LOC	OBJECT CODE	ADDR1	ADDR2	STMT
				469 **** 470 * Normal completion or Abnormal termination PSWs 471 ****
00000618	00020001 80000000			473 EOJPSW DC OD' 0' , X' 0002000180000000' , AD(0)
00000628	B2B2 8418	00000618	475 EOJ LPSWE EOJPSW	Normal completion
00000630	00020001 80000000			477 FAILPSW DC OD' 0' , X' 0002000180000000' , AD(X' BAD')
00000640	B2B2 8430	00000630	479 FAILTEST LPSWE FAILPSW	Abnormal termination
				481 **** 482 * Working Storage 483 ****
00000644	00000000		485 CTLR0 DS F	CR0
00000648	00000000		486 DS F	
0000064C			488	
0000064C	00000080		489 LTORG ,	Literals pool
00000650	00003868		490 =F' 128'	
00000654	00000000		491 =A(E6TESTS)	
00000658	00000002		492 =F' 0'	
0000065C	00000003		493 =F' 2'	
00000660	00000004		494 =F' 3'	
00000664	00000001		495 =F' 4'	
00000668	0000		496 =F' 1'	
0000066A	005F		497 =H' 0'	
			498 =AL2(L' MSGMSG)	
			499	
			500 *	some constants
			501	
	00000400	00000001	502 K EQU 1024	One KB
	00001000	00000001	503 PAGE EQU (4*K)	Size of one page
	00010000	00000001	504 K64 EQU (64*K)	64 KB
	00100000	00000001	505 MB EQU (K*K)	1 MB
	AABBCCDD	00000001	506	
	000000DD	00000001	507 REG2PATT EQU X' AABBCCDD'	Polluted Register pattern
			508 REG2LOW EQU X' DD'	(last byte above)

LOC	OBJECT CODE	ADDR1	ADDR2	STMT
				510 *=====
				511 *
				512 * NOTE: start data on an address that is easy to display
				513 * within Hercules
				514 *
				515 *=====
				516
0000066C		0000066C	00001000	517 ORG ZVE6TST+X'1000'
00001000	00000000			518 FAILED DC F'0'
00001004	00000000			519 TESTING DC F'0'
				some test failed? current test #
				521 *****
				522 * TEST failed : result messgae
				523 *****
				524 *
				525 * failed message and associated editting
				526 *
00001008	40404040 4040E385			527 PRTLINE DC C' Test #'
00001015	A7A7A7			528 PRTPNUM DC C'xxx'
00001018	40868189 93858440			529 DC c' failed for instruction '
00001030	A7A7A7A7 A7A7A7A7			530 PRTNAME DC CL8'xxxxxxxx'
00001038	40A689A3 884094F4			531 DC C' with m4='
00001041	A7A7			532 PRTM4 DC C'xx'
00001043	6B40A689 A3884094			533 DC C', with m5='
0000104D	A7A7			534 PRTM5 DC C'xx'
0000104F	6B40A689 A38840A2			535 DC C', with scale='
0000105C	A7A7A7			536 PRTSCALE DC C'xxx'
0000105F	4B			537 DC C'.'
		00000058	00000001	538 PRTLNG EQU *-PRTLINE
				540 *****
				541 * TEST failed : XCHECK
				542 *****
				543 *
				544 * XCHECK failed message
				545 *
00001060	40404040 4040E385			546 XCPLINE DC C' Test #'
0000106D	A7A7A7			547 XCPTNUM DC C'xxx'
00001070	40E7C3C8 C5C3D240			548 DC c' XCHECK failed for instruction '
0000108F	A7A7A7A7 A7A7A7A7			549 XCPNAME DC CL8'xxxxxxxx'
00001097	40A689A3 884094F4			550 DC C' with m4='
000010A0	A7A7			551 XCPM4 DC C'xx'
000010A2	6B40A689 A3884094			552 DC C', with m5='
000010AC	A7A7			553 XCPM5 DC C'xx'
000010AE	6B40A689 A38840A2			554 DC C', with scale='
000010BB	A7A7A7			555 XCPSCALE DC C'xxx'
000010BE	4B			556 DC C'.'
		0000005F	00000001	557 XCPLNG EQU *-XCPLINE

LOC	OBJECT CODE	ADDR1	ADDR2	STMT
				580 **** 581 * E6TEST DSECT 582 ****
00000000	00000000			584 E6TEST DSECT ,
00000004	0000			585 TSUB DC A(0) 586 TNUM DC H'00'
00000006	00			587 DC X'00'
00000007	00			588 M4 DC HL1'00'
00000008	00			589 M5 DC HL1'00'
00000009	00			590 SCALE DC HL1'00'
0000000C	00000000			591 V2ADDR DC A(0)
00000010	40404040	40404040		592 OPNAME DC CL8' '
00000018	00000000			593 RELEN DC A(0)
0000001C	00000000			594 READDR DC A(0)
				595
				596 **
				597 * test routine will be here (from VRR-b macro)
0000115C	00000000	00003A17		599 ZVE6TST CSECT , 600 DS OF
				602 ****
				603 * Macros to help build test tables
				604 ****
				606 *
				607 * macro to generate individual test
				608 *
				609 MACRO
				610 VRR_B &INST, &M4, &M5, &SCALE
				611 . * &INST - VRR-b instruction under test
				612 . * &M4 - M4 field
				613 . * &M5 - M5 field
				614 GBLA &TNUM
		&TNUM		615 SETA &TNUM+1
				616
				617 DS OFD
				618 USING *, R5
				base for test data and test routine
				619
				620 T&TNUM DC A(X&TNUM)
				621 DC H'&TNUM
				622 DC X'00'
				623 DC HL1'&M4'
				624 DC HL1'&M5'
				625 V3_&TNUM DC HL1'&SCALE'
				626 V2_&TNUM DC A(RE&TNUM+16)
				627 DC CL8'&INST'
				628 DC A(16)
				629 DC A(RE&TNUM)
				630 . *

LOC	OBJECT CODE	ADDR1	ADDR2	STMT
631	*			
632	X&TNUM	DS	OF	
633		VL	V1, V1FUDGE	fudge V1
634				
635		LGF	R2, V2_&TNUM	get v2
636		VL	V2, 0(R2)	
637				
638		VLEB	V3, V3_&TNUM, 7	get v3 scale
639				
640		&INST	V1, V2, V3, &M4, &M5	test instruction
641				
642		BR	R11	return
643				
644	RE&TNUM	DS	OF	expected 16 byte result
645		DROP	R5	
646				
647		MEND		
649	*			
650	*	macro to generate table of pointers to individual tests		
651	*			
652		MACRO		
653		PTTABLE		
654		GBLA	&TNUM	
655		LCLA	&CUR	
656	&CUR	SETA	1	
657	.			
658	TTABLE	DS	OF	
659	. LOOP	ANOP		
660	.	*		
661		DC	A(T&CUR)	TEST &CUR
662	.	*		
663	&CUR	SETA	&CUR+1	
664		AIF	(&CUR LE &TNUM).LOOP	
665	*			
666		DC	A(0)	END OF TABLE
667		DC	A(0)	
668	.	*		
669		MEND		

LOC	OBJECT CODE	ADDR1	ADDR2	STMT
				671 **** 672 * E6 VRR-b tests 673 **** 674 PRINT DATA 675 *
				676 * E674 VSCHP - DECIMAL SCALE AND CONVERT TO HFP 677 * 678 *----- 679 * VSCHP - DECIMAL SCALE AND CONVERT TO HFP 680 *----- 681 * VRR-b instruction, m4, m5, scale(0-8) 682 * followed by 683 *----- 684 * followed by 685 * v1 - 16 byte expected result 686 *----- 687 * v2 - 16 byte zoned decimal (operand) 688 *----- 689 *----- 690 * short float 691 *----- 692 * +0 693 VRR_B VSCHP, 2, 0, 0
00001160				694+ DS OFD
00001160		00001160		695+ USING *, R5
00001160	00001180			696+T1 DC A(X1)
00001164	0001			697+ DC H' 1'
00001166	00			698+ DC X' 00'
00001167	02			699+ DC HL1' 2'
00001168	00			700+ DC HL1' 0'
00001169	00			701+V3_1 DC HL1' 0'
0000116C	000011B0			702+V2_1 DC A(RE1+16)
00001170	E5E2C3C8 D7404040			703+ DC CL8' VSCHP'
00001178	00000010			704+ DC A(16)
0000117C	000011A0			705+ DC A(RE1)
				706+*
00001180				707+X1 DS OF
00001180	E710 8F2C 0006	0000112C		708+ VL V1, V1FUDGE
00001186	E320 500C 0014	0000116C		709+ LGF R2, V2_1
0000118C	E722 0000 0006	00000000		710+ VL V2, 0(R2)
00001192	E730 5009 7000	00001169		711+ VLEB V3, V3_1, 7
00001198	E612 3000 2074			712+ VSCHP V1, V2, V3, 2, 0
0000119E	07FB			713+ BR R11
000011A0				714+RE1 DS OF
000011A0	00000000 00000000			715+ DROP R5
000011A0	00000000 00000000			716 DC XL16' 00000000000000000000000000000000'
000011A8	00000000 00000000			
000011B0	00000000 00000000			717 DC XL16' 00000000000000000000000000000000C'
000011B8	00000000 0000000C			718 * - 0
				719 VRR_B VSCHP, 2, 0, 0
000011C0				720+ DS OFD
000011C0		000011C0		721+ USING *, R5
000011C0	000011E0			722+T2 DC A(X2)
000011C4	0002			723+ DC H' 2'
000011C6	00			724+ DC X' 00'

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
000011C7	02			725+	DC	HL1' 2'
000011C8	00			726+	DC	HL1' 0'
000011C9	00			727+V3_2	DC	HL1' 0'
000011CC	00001210			728+V2_2	DC	A(RE2+16)
000011D0	E5E2C3C8 D7404040			729+	DC	CL8' VSCHP'
000011D8	00000010			730+	DC	A(16)
000011DC	00001200			731+	DC	A(RE2)
				732+*		
000011E0				733+X2	DS	OF
000011E0	E710 8F2C 0006	0000112C		734+	VL	V1, V1FUDGE
000011E6	E320 500C 0014	000011CC		735+	LGF	R2, V2_2
000011EC	E722 0000 0006	00000000		736+	VL	V2, 0(R2)
000011F2	E730 5009 7000	000011C9		737+	VLEB	V3, V3_2, 7
000011F8	E612 3000 2074			738+	VSCHP	V1, V2, V3, 2, 0
000011FE	07FB			739+	BR	R11
00001200				740+RE2	DS	OF
00001200				741+	DROP	R5
00001200	00000000 00000000			742	DC	XL16' 00000000000000000000000000000000'
00001208	00000000 00000000			743	DC	XL16' 00000000000000000000000000000000D'
00001210	00000000 00000000					
00001218	00000000 0000000D			744 * +1		
				745	VRR_B	VSCHP, 2, 0, 0
00001220				746+	DS	OFD
00001220	00001240	00001220		747+	USING	*, R5
00001220				748+T3	DC	A(X3)
00001224	0003			749+	DC	H' 3'
00001226	00			750+	DC	X' 00'
00001227	02			751+	DC	HL1' 2'
00001228	00			752+	DC	HL1' 0'
00001229	00			753+V3_3	DC	HL1' 0'
0000122C	00001270			754+V2_3	DC	A(RE3+16)
00001230	E5E2C3C8 D7404040			755+	DC	CL8' VSCHP'
00001238	00000010			756+	DC	A(16)
0000123C	00001260			757+	DC	A(RE3)
				758+*		
00001240				759+X3	DS	OF
00001240	E710 8F2C 0006	0000112C		760+	VL	V1, V1FUDGE
00001246	E320 500C 0014	0000122C		761+	LGF	R2, V2_3
0000124C	E722 0000 0006	00000000		762+	VL	V2, 0(R2)
00001252	E730 5009 7000	00001229		763+	VLEB	V3, V3_3, 7
00001258	E612 3000 2074			764+	VSCHP	V1, V2, V3, 2, 0
0000125E	07FB			765+	BR	R11
00001260				766+RE3	DS	OF
00001260	41100000 00000000			767+	DROP	R5
00001268	00000000 00000000			768	DC	XL16' 41100000000000000000000000000000'
00001270	00000000 00000000			769	DC	XL16' 000000000000000000000000000000001C'
00001278	00000000 0000001C					
				770 * -1		
00001280				771	VRR_B	VSCHP, 2, 0, 0
00001280	00001280			772+	DS	OFD
00001280	000012A0			773+	USING	*, R5
00001284	0004			774+T4	DC	A(X4)
00001286	00			775+	DC	H' 4'
				776+	DC	X' 00'

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
00001344	0006			829+	DC H' 6'	test number
00001346	00			830+	DC X' 00'	
00001347	02			831+	DC HL1' 2'	m4
00001348	00			832+	DC HL1' 0'	m5
00001349	00			833+V3_6	DC HL1' 0'	scale
0000134C	00001390			834+V2_6	DC A(REQ+16)	address of v2: 16-byte packed decimal
00001350	E5E2C3C8 D7404040			835+	DC CL8' VSCHP'	instruction name
00001358	00000010			836+	DC A(16)	result length
0000135C	00001380			837+	DC A(REQ)	address of expected result
00001360				838+*		
00001360	E710 8F2C 0006	0000112C		839+X6	DS OF	
00001366	E320 500C 0014	0000134C		840+	VL V1, V1FUDGE	fudge V1
0000136C	E722 0000 0006	00000000		841+	LGF R2, V2_6	get v2
00001372	E730 5009 7000	00001349		842+	VL V2, 0(R2)	
00001378	E612 3000 2074			843+	VLEB V3, V3_6, 7	get v3 scale
0000137E	07FB			844+	VSCHP V1, V2, V3, 2, 0	test instruction
00001380				845+	BR R11	return
00001380				846+RE6	DS OF	expected 16 byte result
00001380				847+	DROP R5	
00001380	D0800000 00000000			848	DC XL16' D08000000000000000000000000000000'	
00001388	00000000 00000000					
00001390	00000000 00009223			849	DC XL16' 0000000000009223372036854775808D'	
00001398	37203685 4775808D					
000013A0				850		
000013A0				851 *	9223372036854775807	
000013A0	000013C0	000013A0		852	VRR_B VSCHP, 2, 0, 0	
000013A4	0007			853+	DS OFD	
000013A6	00			854+	USING *, R5	base for test data and test routine
000013A7	02			855+T7	DC A(X7)	address of test routine
000013A8	00			856+	DC H' 7'	test number
000013A9	00			857+	DC X' 00'	
000013AC	000013F0			858+	DC HL1' 2'	m4
000013B0	E5E2C3C8 D7404040			859+	DC HL1' 0'	m5
000013B8	00000010			860+V3_7	DC HL1' 0'	scale
000013BC	000013E0			861+V2_7	DC A(REQ+16)	address of v2: 16-byte packed decimal
000013C0				862+	DC CL8' VSCHP'	instruction name
000013C6	E320 500C 0014	000013AC		863+	DC A(16)	result length
000013CC	E722 0000 0006	00000000		864+	DC A(REQ)	address of expected result
000013D2	E730 5009 7000	000013A9		865+*		
000013D8	E612 3000 2074			866+X7	DS OF	
000013DE	07FB			867+	VL V1, V1FUDGE	fudge V1
000013E0				868+	LGF R2, V2_7	get v2
000013E0	507FFFFF 00000000			869+	VL V2, 0(R2)	
000013E8	00000000 00000000			870+	VLEB V3, V3_7, 7	get v3 scale
000013F0	00000000 00009223			871+	VSCHP V1, V2, V3, 2, 0	test instruction
000013F8	37203685 4775807C			872+	BR R11	return
000013E0				873+RE7	DS OF	expected 16 byte result
000013E0				874+	DROP R5	
000013E8				875	DC XL16' 507FFFFF000000000000000000000000'	
000013F0				876	DC XL16' 0000000000009223372036854775807C'	
000013F8				877		
00001400				878 *	18446744073709551615	
00001400				879	VRR_B VSCHP, 2, 0, 0	
00001400				880+	DS OFD	

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
000014B8	00000000 0000000C			934 * -0		
000014C0				935 VRR_B VSCHP, 3, 0, 0		
000014C0				936+ DS OFD		
000014C0		000014C0		937+ USING *, R5	base for test data and test routine	
000014C0	000014E0			938+T10 DC A(X10)	address of test routine	
000014C4	000A			939+ DC H' 10'	test number	
000014C6	00			940+ DC X' 00'		
000014C7	03			941+ DC HL1' 3'	m4	
000014C8	00			942+ DC HL1' 0'	m5	
000014C9	00			943+V3_10 DC HL1' 0'	scale	
000014CC	00001510			944+V2_10 DC A(RE10+16)	address of v2: 16-byte packed decimal	
000014D0	E5E2C3C8 D7404040			945+ DC CL8' VSCHP'	instruction name	
000014D8	00000010			946+ DC A(16)	result length	
000014DC	00001500			947+ DC A(RE10)	address of expected result	
000014E0				948+*		
000014E0				949+X10 DS OF		
000014E0	E710 8F2C 0006	0000112C		950+ VL V1, V1FUDGE	fudge V1	
000014E6	E320 500C 0014	000014CC		951+ LGF R2, V2_10	get v2	
000014EC	E722 0000 0006	00000000		952+ VL V2, 0(R2)		
000014F2	E730 5009 7000	000014C9		953+ VLEB V3, V3_10, 7	get v3 scale	
000014F8	E612 3000 3074			954+ VSCHP V1, V2, V3, 3, 0	test instruction	
000014FE	07FB			955+ BR R11	return	
00001500				956+RE10 DS OF	expected 16 byte result	
00001500				957+ DROP R5		
00001500	00000000 00000000			958 DC XL16' 00000000000000000000000000000000'		
00001508	00000000 00000000			959 DC XL16' 00000000000000000000000000000000D'		
00001510	00000000 00000000			960 * +1		
00001510	00000000 0000000D			961 VRR_B VSCHP, 3, 0, 0		
00001520				962+ DS OFD		
00001520		00001520		963+ USING *, R5	base for test data and test routine	
00001520	00001540			964+T11 DC A(X11)	address of test routine	
00001524	000B			965+ DC H' 11'	test number	
00001526	00			966+ DC X' 00'		
00001527	03			967+ DC HL1' 3'	m4	
00001528	00			968+ DC HL1' 0'	m5	
00001529	00			969+V3_11 DC HL1' 0'	scale	
0000152C	00001570			970+V2_11 DC A(RE11+16)	address of v2: 16-byte packed decimal	
00001530	E5E2C3C8 D7404040			971+ DC CL8' VSCHP'	instruction name	
00001538	00000010			972+ DC A(16)	result length	
0000153C	00001560			973+ DC A(RE11)	address of expected result	
00001540				974+*		
00001540	E710 8F2C 0006	0000112C		975+X11 DS OF		
00001546	E320 500C 0014	0000152C		976+ VL V1, V1FUDGE	fudge V1	
0000154C	E722 0000 0006	00000000		977+ LGF R2, V2_11	get v2	
00001552	E730 5009 7000	00001529		978+ VL V2, 0(R2)		
00001558	E612 3000 3074			979+ VLEB V3, V3_11, 7	get v3 scale	
0000155E	07FB			980+ VSCHP V1, V2, V3, 3, 0	test instruction	
00001560				981+ BR R11	return	
00001560				982+RE11 DS OF	expected 16 byte result	
00001560	41100000 00000000			983+ DROP R5		
00001568	00000000 00000000			984 DC XL16' 41100000000000000000000000000000'		
00001570	00000000 00000000			985 DC XL16' 00000000000000000000000000000001C'		

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
000016E0	507FFFFF FFFFFFFF			1091	DC	XL16' 507FFFFFFFFFFFFFFF0000000000000000'
000016E8	00000000 00000000			1092	DC	XL16' 0000000000009223372036854775807C'
000016F0	00000000 00009223			1093		
000016F8	37203685 4775807C			1094 * 18446744073709551615		
				1095 VRR_B VSCHP, 3, 0, 0		
00001700		00001700		1096+ DS OFD		
00001700	00001720			1097+ USING *, R5		base for test data and test routine
00001700	0010			1098+T16 DC A(X16)		address of test routine
00001704	00			1099+ DC H' 16'		test number
00001706	03			1100+ DC X' 00'		
00001707	00			1101+ DC HL1' 3'	m4	
00001708	00			1102+ DC HL1' 0'	m5	
00001709	00			1103+V3_16 DC HL1' 0'	scale	
0000170C	00001750			1104+V2_16 DC A(RE16+16)	address of v2: 16-byte packed decimal	
00001710	E5E2C3C8 D7404040			1105+ DC CL8' VSCHP'	instruction name	
00001718	00000010			1106+ DC A(16)	result length	
0000171C	00001740			1107+ DC A(RE16)	address of expected result	
				1108+*		
00001720				1109+X16 DS OF		
00001720	E710 8F2C 0006	0000112C	1110+	VL V1, V1FUDGE	fudge V1	
00001726	E320 500C 0014	0000170C	1111+	LGF R2, V2_16	get v2	
0000172C	E722 0000 0006	00000000	1112+	VL V2, 0(R2)		
00001732	E730 5009 7000	00001709	1113+	VLEB V3, V3_16, 7	get v3 scale	
00001738	E612 3000 3074		1114+	VSCHP V1, V2, V3, 3, 0	test instruction	
0000173E	07FB		1115+	BR R11	return	
00001740			1116+RE16	DS OF	expected 16 byte result	
00001740	50FFFFFF FFFFFFFF		1117+ DROP R5			
00001748	00000000 00000000		1118	DC XL16' 50FFFFFFFFFFFFFF0000000000000000'		
00001750	00000000 00018446		1119	DC XL16' 0000000000018446744073709551615C'		
00001758	74407370 9551615C		1120			
			1121 *			
			1122 * extended float			
			1123 *			
			1124 * +0			
00001760		00001760		1125 VRR_B VSCHP, 4, 0, 0		
00001760	00001780		1126+ DS OFD			
00001760	0011		1127+ USING *, R5		base for test data and test routine	
00001764	0011		1128+T17 DC A(X17)		address of test routine	
00001766	00		1129+ DC H' 17'		test number	
00001767	04		1130+ DC X' 00'			
00001768	00		1131+ DC HL1' 4'	m4		
00001769	00		1132+ DC HL1' 0'	m5		
0000176C	000017B0		1133+V3_17 DC HL1' 0'	scale		
00001770	E5E2C3C8 D7404040		1134+V2_17 DC A(RE17+16)	address of v2: 16-byte packed decimal		
00001778	00000010		1135+ DC CL8' VSCHP'	instruction name		
0000177C	000017A0		1136+ DC A(16)	result length		
			1137+ DC A(RE17)	address of expected result		
			1138+*			
00001780			1139+X17 DS OF			
00001780	E710 8F2C 0006	0000112C	1140+ VL V1, V1FUDGE	fudge V1		
00001786	E320 500C 0014	0000176C	1141+ LGF R2, V2_17	get v2		
0000178C	E722 0000 0006	00000000	1142+ VL V2, 0(R2)			

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00001792	E730 5009 7000		00001769	1143+ 1144+ 1145+ 1146+RE17 1147+	VLEB VSCHP BR DS DROP	V3, V3_17, 7 V1, V2, V3, 4, 0 R11 OF R5	get v3 scale test instruction return expected 16 byte result
00001798	E612 3000 4074	07FB		1148	DC	XL16' 00000000000000000000000000000000'	
000017A0	00000000 00000000			1149	DC	XL16' 00000000000000000000000000000000C'	
000017A0	00000000 00000000			1150 * -0			
000017A8	00000000 00000000			1151	VRR_B	VSCHP, 4, 0, 0	
000017B0	00000000 00000000			1152+ 1153+ 1154+T18	DS USING DC	OFD *, R5 A(X18)	base for test data and test routine address of test routine
000017B8	00000000 0000000C			1155+ 1156+ 1157+ 1158+ 1159+V3_18 1160+V2_18	DC DC DC DC DC DC	H' 18' X' 00' HL1' 4' HL1' 0' HL1' 0' A(RE18+16)	test number m4 m5 scale address of v2: 16-byte packed decimal
000017C0	000017E0	000017C0		1161+ 1162+ 1163+	DC DC DC	CL8' VSCHP' A(16) A(RE18)	instruction name result length address of expected result
000017C4	0012			1164+*			
000017C6	00			1165+X18	DS	OF	
000017C7	04			1166+ 1167+ 1168+ 1169+	VL LGF VL VLEB	V1, V1FUDGE R2, V2_18 V2, 0(R2) V3, V3_18, 7	fudge V1 get v2 get v3 scale
000017CC	00001810			1170+ 1171+ 1172+RE18	VSCHP BR DS	V1, V2, V3, 4, 0 R11 OF	test instruction return expected 16 byte result
000017D0	E5E2C3C8 D7404040			1173+ 1174	DROP DC	R5 XL16' 00000000000000000000000000000000'	
000017D8	00000010			1175	DC	XL16' 00000000000000000000000000000000D'	
000017DC	00001800			1176 * +1			
000017E0	E710 8F2C 0006		0000112C	1177 1178+ 1179+	VRR_B	VSCHP, 4, 0, 0 OFD USING	
000017E6	E320 500C 0014		000017CC	* , R5			base for test data and test routine
000017EC	E722 0000 0006		00000000	1180+T19	DC	A(X19)	address of test routine
000017F2	E730 5009 7000		000017C9	1181+ 1182+	DC DC	H' 19' X' 00'	test number
000017F8	E612 3000 4074	07FB		1183+ 1184+ 1185+V3_19	DC DC DC	HL1' 4' HL1' 0' HL1' 0'	m4 m5 scale
00001800	00000000 00000000			1186+V2_19	DC	A(RE19+16)	address of v2: 16-byte packed decimal
00001808	00000000 00000000			1187+ 1188+	DC DC	CL8' VSCHP' A(16)	instruction name result length
00001810	00000000 00000000			1189+	DC	A(RE19)	address of expected result
00001818	00000000 0000000D			1190+*			
00001820	00001840	00001820		1191+X19	DS	OF	
00001824	0013			1192+	VL	V1, V1FUDGE	fudge V1
00001826	00			1193+	LGF	R2, V2_19	get v2
00001827	04			1194+	VL	V2, 0(R2)	
00001828	00						
00001829	00						
0000182C	00001870						
00001830	E5E2C3C8 D7404040						
00001838	00000010						
0000183C	00001860						
00001840	E710 8F2C 0006		0000112C				
00001846	E320 500C 0014		0000182C				
0000184C	E722 0000 0006		00000000				
			1194+				

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00001852	E730 5009 7000		00001829	1195+ VLEB 1196+ VSCHP	V3, V3_19, 7 V1, V2, V3, 4, 0	get v3 scale	
00001858	E612 3000 4074			1197+ BR 1198+RE19 DS 1199+ DROP	R11 OF R5	test instruction return expected 16 byte result	
0000185E	07FB			1200 DC	XL16' 41100000000000003300000000000000'		
00001860	41100000 00000000			1201 DC	XL16' 00000000000000000000000000000001C'		
00001868	33000000 00000000			1202 * -1			
00001870	00000000 00000000		00001880	1203 VRR_B VSCHP, 4, 0, 0		base for test data and test routine	
00001878	00000000 0000001C			1204+ DS 1205+ USING 1206+T20 DC	OFD *, R5 A(X20)	address of test routine	
00001880	000018A0	00001880		1207+ DC 1208+ DC 1209+ DC	H' 20' X' 00' HL1' 4'	test number	
00001884	0014			1210+ DC 1211+V3_20 DC 1212+V2_20 DC	HL1' 0' HL1' 0' A(RE20+16)	m4 m5 scale	
00001886	00			1213+ DC	CL8' VSCHP'	address of v2: 16-byte packed decimal	
00001887	04			1214+ DC 1215+ DC	A(16) A(RE20)	instruction name result length	
00001888	00			1216+*		address of expected result	
00001889	00			1217+X20 DS	OF		
0000188C	000018D0			1218+ VL	V1, V1FUDGE	fudge V1	
00001890	E5E2C3C8 D7404040			1219+ LGF	R2, V2_20	get v2	
00001898	00000010			1220+ VL	V2, 0(R2)		
0000189C	000018C0			1221+ VLEB	V3, V3_20, 7	get v3 scale	
000018A0				1222+ VSCHP	V1, V2, V3, 4, 0	test instruction	
000018A0	E710 8F2C 0006	0000112C		1223+ BR	R11	return	
000018A6	E320 500C 0014	0000188C		1224+RE20 DS	OF	expected 16 byte result	
000018AC	E722 0000 0006	00000000		1225+ DROP	R5		
000018B2	E730 5009 7000	00001889		1226 DC	XL16' C11000000000000B300000000000000'		
000018B8	E612 3000 4074			1227 DC	XL16' 00000000000000000000000000000001D'		
000018BE	07FB			1228			
000018C0				1229 * +9000000000000001			
000018C0	C1100000 00000000			1230 VRR_B VSCHP, 4, 0, 0		base for test data and test routine	
000018C8	B3000000 00000000			1231+ DS	OFD	address of test routine	
000018D0	00000000 00000000			1232+ USING	*, R5	test number	
000018D8	00000000 0000001D		000018E0	1233+T21 DC	A(X21)		
000018E0				1234+ DC	H' 21'		
000018E0	00001900	000018E0		1235+ DC	X' 00'		
000018E4	0015			1236+ DC	HL1' 4'	m4	
000018E6	00			1237+ DC	HL1' 0'	m5	
000018E7	04			1238+V3_21 DC	HL1' 0'	scale	
000018E8	00			1239+V2_21 DC	A(RE21+16)	address of v2: 16-byte packed decimal	
000018E9	00			1240+ DC	CL8' VSCHP'	instruction name	
000018EC	00001930			1241+ DC	A(16)	result length	
000018F0	E5E2C3C8 D7404040			1242+ DC	A(RE21)	address of expected result	
000018F8	00000010			1243+*			
000018FC	00001920			1244+X21 DS	OF		
00001900				1245+ VL	V1, V1FUDGE	fudge V1	
00001900	E710 8F2C 0006	0000112C		1246+ LGF	R2, V2_21	get v2	
00001906	E320 500C 0014	000018EC					

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
0000190C	E722 0000 0006		00000000	1247+	VL	V2, 0(R2)	
00001912	E730 5009 7000		000018E9	1248+	VLEB	V3, V3_21, 7	get v3 scale
00001918	E612 3000 4074			1249+	VSCHP	V1, V2, V3, 4, 0	test instruction
0000191E	07FB			1250+	BR	R11	return
00001920				1251+RE21	DS	OF	expected 16 byte result
00001920				1252+	DROP	R5	
00001920	4E1FF973 CAFA8001			1253	DC	XL16' 4E1FF973CAFA80014000000000000000'	
00001928	40000000 00000000						
00001930	00000000 00000009			1254	DC	XL16' 00000000000000090000000000000001C'	
00001938	00000000 0000001C			1255			
				1256 * - 9223372036854775808			
				1257	VRR_B	VSCHP, 4, 0, 0	
00001940		00001940		1258+	DS	OFD	
00001940	00001960			1259+	USING	*, R5	base for test data and test routine
00001944	0016			1260+T22	DC	A(X22)	address of test routine
00001946	00			1261+	DC	H' 22'	test number
00001947	04			1262+	DC	X' 00'	
00001948	00			1263+	DC	HL1' 4'	m4
				1264+	DC	HL1' 0'	m5
00001949	00			1265+V3_22	DC	HL1' 0'	scale
0000194C	00001990			1266+V2_22	DC	A(RE22+16)	address of v2: 16-byte packed decimal
00001950	E5E2C3C8 D7404040			1267+	DC	CL8' VSCHP'	instruction name
00001958	00000010			1268+	DC	A(16)	result length
0000195C	00001980			1269+	DC	A(RE22)	address of expected result
00001960				1270+*			
00001960	E710 8F2C 0006	0000112C		1271+X22	DS	OF	
00001966	E320 500C 0014	0000194C		1272+	VL	V1, V1FUDGE	fudge V1
0000196C	E722 0000 0006	00000000		1273+	LGF	R2, V2_22	get v2
00001972	E730 5009 7000	00001949		1274+	VL	V2, 0(R2)	
00001978	E612 3000 4074			1275+	VLEB	V3, V3_22, 7	get v3 scale
0000197E	07FB			1276+	VSCHP	V1, V2, V3, 4, 0	test instruction
00001980				1277+	BR	R11	return
00001980				1278+RE22	DS	OF	expected 16 byte result
00001980				1279+	DROP	R5	
00001980	D0800000 00000000			1280	DC	XL16' D080000000000000C200000000000000'	
00001988	C2000000 00000000						
00001990	00000000 00009223			1281	DC	XL16' 0000000000009223372036854775808D'	
00001998	37203685 4775808D			1282			
				1283 * 9223372036854775807			
000019A0		000019A0		1284	VRR_B	VSCHP, 4, 0, 0	
000019A0	000019C0			1285+	DS	OFD	
000019A0	0017			1286+	USING	*, R5	base for test data and test routine
000019A4	0017			1287+T23	DC	A(X23)	address of test routine
000019A6	00			1288+	DC	H' 23'	test number
000019A7	04			1289+	DC	X' 00'	
000019A8	00			1290+	DC	HL1' 4'	m4
000019A9	00			1291+	DC	HL1' 0'	m5
				1292+V3_23	DC	HL1' 0'	scale
000019AC	000019F0			1293+V2_23	DC	A(RE23+16)	address of v2: 16-byte packed decimal
000019B0	E5E2C3C8 D7404040			1294+	DC	CL8' VSCHP'	instruction name
000019B8	00000010			1295+	DC	A(16)	result length
000019BC	000019E0			1296+	DC	A(RE23)	address of expected result
000019C0				1297+*			
				1298+X23	DS	OF	

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
000019C0	E710 8F2C 0006		0000112C	1299+ VL V1, V1FUDGE		fudge V1	
000019C6	E320 500C 0014		000019AC	1300+ LGF R2, V2_23		get v2	
000019CC	E722 0000 0006		00000000	1301+ VL V2, 0(R2)			
000019D2	E730 5009 7000		000019A9	1302+ VLEB V3, V3_23, 7		get v3 scale	
000019D8	E612 3000 4074			1303+ VSCHP V1, V2, V3, 4, 0		test instruction	
000019DE	07FB			1304+ BR R11		return	
000019E0				1305+RE23 DS OF		expected 16 byte result	
000019E0				1306+ DROP R5			
000019E0	507FFFFF FFFFFFFF			1307 DC XL16' 507FFFFFFFFFFFF42FF000000000000'			
000019E8	42FF0000 00000000			1308 DC XL16' 0000000000009223372036854775807C'			
000019F8	37203685 4775807C			1309			
				1310 * 18446744073709551615			
00001A00				1311 VRR_B VSCHP, 4, 0, 0			
00001A00		00001A00		1312+ DS OFD			
00001A00	00001A20			1313+ USING *, R5		base for test data and test routine	
00001A04	0018			1314+T24 DC A(X24)		address of test routine	
00001A06	00			1315+ DC H' 24'		test number	
00001A07	04			1316+ DC X' 00'			
00001A08	00			1317+ DC HL1' 4'		m4	
00001A09	00			1318+ DC HL1' 0'		m5	
00001A09				1319+V3_24 DC HL1' 0'		scale	
00001A0C	00001A50			1320+V2_24 DC A(RE24+16)		address of v2: 16-byte packed decimal	
00001A10	E5E2C3C8 D7404040			1321+ DC CL8' VSCHP'		instruction name	
00001A18	00000010			1322+ DC A(16)		result length	
00001A1C	00001A40			1323+ DC A(RE24)		address of expected result	
00001A24				1324+* 1325+X24 DS OF			
00001A20	E710 8F2C 0006		0000112C	1326+ VL V1, V1FUDGE		fudge V1	
00001A26	E320 500C 0014		00001A0C	1327+ LGF R2, V2_24		get v2	
00001A2C	E722 0000 0006		00000000	1328+ VL V2, 0(R2)			
00001A32	E730 5009 7000		00001A09	1329+ VLEB V3, V3_24, 7		get v3 scale	
00001A38	E612 3000 4074			1330+ VSCHP V1, V2, V3, 4, 0		test instruction	
00001A3E	07FB			1331+ BR R11		return	
00001A40				1332+RE24 DS OF		expected 16 byte result	
00001A40				1333+ DROP R5			
00001A40	50FFFFFF FFFFFFFF			1334 DC XL16' 50FFFFFFFFFFFF42FF000000000000'			
00001A48	42FF0000 00000000			1335 DC XL16' 00000000000018446744073709551615C'			
00001A50	00000000 00018446			1336			
00001A58	74407370 9551615C			1337 *-----			
				1338 * No Rounding - with shifts			
				1339 *-----			
				1340 *-----			
				1341 * short float			
				1342 *-----			
				1343 * +0			
				1344 VRR_B VSCHP, 2, 0, 1			
00001A60				1345+ DS OFD			
00001A60		00001A60		1346+ USING *, R5		base for test data and test routine	
00001A60	00001A80			1347+T25 DC A(X25)		address of test routine	
00001A64	0019			1348+ DC H' 25'		test number	
00001A66	00			1349+ DC X' 00'			
00001A67	02			1350+ DC HL1' 2'		m4	

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
00001A68	00			1351+	DC	HL1' 0'
00001A69	01			1352+V3_25	DC	HL1' 1'
00001A6C	00001AB0			1353+V2_25	DC	A(RE25+16)
00001A70	E5E2C3C8 D7404040			1354+	DC	CL8' VSCHP'
00001A78	00000010			1355+	DC	A(16)
00001A7C	00001AA0			1356+	DC	A(RE25)
				1357+*		
00001A80				1358+X25	DS	OF
00001A80	E710 8F2C 0006	0000112C		1359+	VL	V1, V1FUDGE
00001A86	E320 500C 0014	00001A6C		1360+	LGF	R2, V2_25
00001A8C	E722 0000 0006	00000000		1361+	VL	V2, 0(R2)
00001A92	E730 5009 7000	00001A69		1362+	VLEB	V3, V3_25, 7
00001A98	E612 3000 2074			1363+	VSCHP	V1, V2, V3, 2, 0
00001A9E	07FB			1364+	BR	R11
00001AA0				1365+RE25	DS	OF
00001AA0				1366+	DROP	R5
00001AA0	00000000 00000000			1367	DC	XL16' 00000000000000000000000000000000'
00001AA8	00000000 00000000			1368	DC	XL16' 00000000000000000000000000000000C'
00001AB0	00000000 00000000					
00001AB8	00000000 0000000C					
				1369 * - 0		
00001AC0				1370	VRR_B	VSCHP, 2, 0, 1
				1371+	DS	OFD
00001AC0		00001AC0		1372+	USING	* , R5
00001AC0	00001AE0			1373+T26	DC	A(X26)
00001AC4	001A			1374+	DC	H' 26'
00001AC6	00			1375+	DC	X' 00'
00001AC7	02			1376+	DC	HL1' 2'
00001AC8	00			1377+	DC	HL1' 0'
00001AC9	01			1378+V3_26	DC	HL1' 1'
00001ACC	00001B10			1379+V2_26	DC	A(RE26+16)
00001AD0	E5E2C3C8 D7404040			1380+	DC	CL8' VSCHP'
00001AD8	00000010			1381+	DC	A(16)
00001ADC	00001B00			1382+	DC	A(RE26)
				1383+*		
00001AE0				1384+X26	DS	OF
00001AE0	E710 8F2C 0006	0000112C		1385+	VL	V1, V1FUDGE
00001AE6	E320 500C 0014	00001ACC		1386+	LGF	R2, V2_26
00001AEC	E722 0000 0006	00000000		1387+	VL	V2, 0(R2)
00001AF2	E730 5009 7000	00001AC9		1388+	VLEB	V3, V3_26, 7
00001AF8	E612 3000 2074			1389+	VSCHP	V1, V2, V3, 2, 0
00001AFE	07FB			1390+	BR	R11
00001B00				1391+RE26	DS	OF
00001B00				1392+	DROP	R5
00001B00	00000000 00000000			1393	DC	XL16' 00000000000000000000000000000000'
00001B08	00000000 00000000					
00001B10	00000000 00000000			1394	DC	XL16' 00000000000000000000000000000000D'
00001B18	00000000 0000000D					
				1395 * +1		
00001B20				1396	VRR_B	VSCHP, 2, 0, 1
00001B20		00001B20		1397+	DS	OFD
00001B20	00001B40			1398+	USING	* , R5
00001B24	001B			1399+T27	DC	A(X27)
00001B26	00			1400+	DC	H' 27'
00001B27	02			1401+	DC	X' 00'
				1402+	DC	HL1' 2'
						m4

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
00001CA4	001F			1507+ DC H' 31'		test number
00001CA6	00			1508+ DC X' 00'		
00001CA7	02			1509+ DC HL1' 2'		m4
00001CA8	00			1510+ DC HL1' 0'		m5
00001CA9	02			1511+V3_31 DC HL1' 2'		scale
00001CAC	00001CF0			1512+V2_31 DC A(RE31+16)		address of v2: 16-byte packed decimal
00001CB0	E5E2C3C8 D7404040			1513+ DC CL8' VSCHP'		instruction name
00001CB8	00000010			1514+ DC A(16)		result length
00001CBC	00001CE0			1515+ DC A(RE31)		address of expected result
				1516+*		
00001CC0				1517+X31 DS OF		
00001CC0	E710 8F2C 0006	0000112C		1518+ VL V1, V1FUDGE		fudge V1
00001CC6	E320 500C 0014	00001CAC		1519+ LGF R2, V2_31		get v2
00001CCC	E722 0000 0006	00000000		1520+ VL V2, 0(R2)		
00001CD2	E730 5009 7000	00001CA9		1521+ VLEB V3, V3_31, 7		get v3 scale
00001CD8	E612 3000 2074			1522+ VSCHP V1, V2, V3, 2, 0		test instruction
00001CDE	07FB			1523+ BR R11		return
00001CE0				1524+RE31 DS OF		expected 16 byte result
00001CE0				1525+ DROP R5		
00001CE0	5231FFFF 00000000			1526 DC XL16' 5231FFFF00000000000000000000000000000000'		
00001CE8	00000000 00000000			1527 DC XL16' 0000000000009223372036854775807C'		
00001CF0	00000000 00009223					
00001CF8	37203685 4775807C					
				1528		
				1529 * 18446744073709551615		
00001D00		00001D00		1530 VRR_B VSCHP, 2, 0, 2		
00001D00	00001D20			1531+ DS OFD		base for test data and test routine
00001D00	00001D20			1532+ USING *, R5		address of test routine
00001D04	0020			1533+T32 DC A(X32)		
00001D06	00			1534+ DC H' 32'		test number
00001D07	02			1535+ DC X' 00'		
00001D08	00			1536+ DC HL1' 2'		m4
00001D09	02			1537+ DC HL1' 0'		m5
00001DOC	00001D50			1538+V3_32 DC HL1' 2'		scale
00001D10	E5E2C3C8 D7404040			1539+V2_32 DC A(RE32+16)		address of v2: 16-byte packed decimal
00001D18	00000010			1540+ DC CL8' VSCHP'		instruction name
00001D1C	00001D40			1541+ DC A(16)		result length
00001D20				1542+ DC A(RE32)		address of expected result
				1543+*		
00001D20	E710 8F2C 0006	0000112C		1544+X32 DS OF		
00001D26	E320 500C 0014	00001DOC		1545+ VL V1, V1FUDGE		fudge V1
00001D2C	E722 0000 0006	00000000		1546+ LGF R2, V2_32		get v2
00001D32	E730 5009 7000	00001D09		1547+ VL V2, 0(R2)		
00001D38	E612 3000 2074			1548+ VLEB V3, V3_32, 7		get v3 scale
00001D3E	07FB			1549+ VSCHP V1, V2, V3, 2, 0		test instruction
00001D40				1550+ BR R11		return
00001D40	5263FFFF 00000000			1551+RE32 DS OF		expected 16 byte result
00001D48	00000000 00000000			1552+ DROP R5		
00001D50	00000000 00018446			1553 DC XL16' 5263FFFF00000000000000000000000000000000'		
00001D58	74407370 9551615C			1554 DC XL16' 00000000000018446744073709551615C'		
				1555		
				1556 *-----		
				1557 * long float		
				1558 *-----		

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
00001F90	00000000 00009223			1716 DC XL16' 0000000000009223372036854775808D'		
00001F98	37203685 4775808D			1717 1718 * 9223372036854775807 1719 VRR_B VSCHP, 3, 0, 2		
00001FA0				1720+ DS OFD		
00001FA0		00001FA0		1721+ USING *, R5	base for test data and test routine	
00001FA0	00001FC0			1722+T39 DC A(X39)	address of test routine	
00001FA4	0027			1723+ DC H' 39'	test number	
00001FA6	00			1724+ DC X' 00'		
00001FA7	03			1725+ DC HL1' 3'	m4	
00001FA8	00			1726+ DC HL1' 0'	m5	
00001FA9	02			1727+V3_39 DC HL1' 2'	scale	
00001FAC	00001FF0			1728+V2_39 DC A(RE39+16)	address of v2: 16-byte packed decimal	
00001FB0	E5E2C3C8 D7404040			1729+ DC CL8' VSCHP'	instruction name	
00001FB8	00000010			1730+ DC A(16)	result length	
00001FBC	00001FE0			1731+ DC A(RE39)	address of expected result	
00001FC0				1732+*		
00001FC0	E710 8F2C 0006	0000112C		1733+X39 DS OF		
00001FC6	E320 500C 0014			1734+ VL V1, V1FUDGE	fudge V1	
00001FCC	E722 0000 0006			1735+ LGF R2, V2_39	get v2	
00001FD2	E730 5009 7000		00000000	1736+ VL V2, 0(R2)		
00001FD2			00001FA9	1737+ VLEB V3, V3_39, 7	get v3 scale	
00001FD8	E612 3000 3074			1738+ VSCHP V1, V2, V3, 3, 0	test instruction	
00001FDE	07FB			1739+ BR R11	return	
00001FE0				1740+RE39 DS OF	expected 16 byte result	
00001FE0				1741+ DROP R5		
00001FE0	5231FFFF FFFFFFFF			1742 DC XL16' 5231FFFFFFFFFFFFFF0000000000000000'		
00001FE8	00000000 00000000			1743 DC XL16' 0000000000009223372036854775807C'		
00001FF0	00000000 00009223			1744		
00001FF8	37203685 4775807C			1745 * 18446744073709551615		
00002000				1746 VRR_B VSCHP, 3, 0, 2		
00002000		00002000		1747+ DS OFD		
00002000	00002020			1748+ USING *, R5	base for test data and test routine	
00002004	0028			1749+T40 DC A(X40)	address of test routine	
00002006	00			1750+ DC H' 40'	test number	
00002007	03			1751+ DC X' 00'		
00002008	00			1752+ DC HL1' 3'	m4	
00002009	02			1753+ DC HL1' 0'	m5	
00002009				1754+V3_40 DC HL1' 2'	scale	
0000200C	00002050			1755+V2_40 DC A(RE40+16)	address of v2: 16-byte packed decimal	
00002010	E5E2C3C8 D7404040			1756+ DC CL8' VSCHP'	instruction name	
00002018	00000010			1757+ DC A(16)	result length	
0000201C	00002040			1758+ DC A(RE40)	address of expected result	
0000201C				1759+*		
00002020				1760+X40 DS OF		
00002020	E710 8F2C 0006	0000112C		1761+ VL V1, V1FUDGE	fudge V1	
00002026	E320 500C 0014		0000200C	1762+ LGF R2, V2_40	get v2	
0000202C	E722 0000 0006		00000000	1763+ VL V2, 0(R2)		
00002032	E730 5009 7000		00002009	1764+ VLEB V3, V3_40, 7	get v3 scale	
00002038	E612 3000 3074			1765+ VSCHP V1, V2, V3, 3, 0	test instruction	
0000203E	07FB			1766+ BR R11	return	
00002040				1767+RE40 DS OF	expected 16 byte result	
00002040				1768+ DROP R5		

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
00002040	5263FFFF FFFFFFFF			1769	DC	XL16' 5263FFFFFFFFFFFFFF0000000000000000'
00002048	00000000 00000000			1770	DC	XL16' 00000000000018446744073709551615C'
00002050	00000000 00018446			1771		
00002058	74407370 9551615C			1772 *-		
				1773 * extended float		
				1774 *-		
				1775 * +0		
00002060				1776 VRR_B VSCHP, 4, 0, 1		
00002060		00002060		1777+ DS OFD		
00002060	00002080			1778+ USING *, R5		base for test data and test routine
00002064	0029			1779+T41 DC A(X41)		address of test routine
00002066	00			1780+ DC H' 41'		test number
00002067	04			1781+ DC X' 00'		
00002068	00			1782+ DC HL1' 4'	m4	
00002069	01			1783+ DC HL1' 0'	m5	
0000206C	000020B0			1784+V3_41 DC HL1' 1'	scale	
00002070	E5E2C3C8 D7404040			1785+V2_41 DC A(RE41+16)	address of v2: 16-byte packed decimal	
				1786+ DC CL8' VSCHP'	instruction name	
00002078	00000010			1787+ DC A(16)	result length	
0000207C	000020A0			1788+ DC A(RE41)	address of expected result	
1789+*						
00002080				1790+X41 DS OF		
00002080	E710 8F2C 0006	0000112C		1791+ VL V1, V1FUDGE	fudge V1	
00002086	E320 500C 0014	0000206C		1792+ LGF R2, V2_41	get v2	
0000208C	E722 0000 0006	00000000		1793+ VL V2, 0(R2)		
00002092	E730 5009 7000	00002069		1794+ VLEB V3, V3_41, 7	get v3 scale	
00002098	E612 3000 4074			1795+ VSCHP V1, V2, V3, 4, 0	test instruction	
0000209E	07FB			1796+ BR R11	return	
000020A0				1797+RE41 DS OF	expected 16 byte result	
000020A0				1798+ DROP R5		
000020A0	00000000 00000000			1799 DC XL16' 00000000000000000000000000000000'		
000020A8	00000000 00000000			1800 DC XL16' 00000000000000000000000000000000C'		
000020B0	00000000 00000000					
000020B8	00000000 0000000C			1801 * - 0		
				1802 VRR_B VSCHP, 4, 0, 1		
000020C0				1803+ DS OFD		
000020C0		000020C0		1804+ USING *, R5		base for test data and test routine
000020C0	000020E0			1805+T42 DC A(X42)		address of test routine
000020C4	002A			1806+ DC H' 42'		test number
000020C6	00			1807+ DC X' 00'		
000020C7	04			1808+ DC HL1' 4'	m4	
000020C8	00			1809+ DC HL1' 0'	m5	
000020C9	01			1810+V3_42 DC HL1' 1'	scale	
000020CC	00002110			1811+V2_42 DC A(RE42+16)	address of v2: 16-byte packed decimal	
000020D0	E5E2C3C8 D7404040			1812+ DC CL8' VSCHP'	instruction name	
000020D8	00000010			1813+ DC A(16)	result length	
000020DC	00002100			1814+ DC A(RE42)	address of expected result	
1815+*						
000020E0				1816+X42 DS OF		
000020E0	E710 8F2C 0006	0000112C		1817+ VL V1, V1FUDGE	fudge V1	
000020E6	E320 500C 0014	000020CC		1818+ LGF R2, V2_42	get v2	
000020EC	E722 0000 0006	00000000		1819+ VL V2, 0(R2)		
000020F2	E730 5009 7000	000020C9	1820+ VLEB V3, V3_42, 7	get v3 scale		

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
000020F8	E612 3000 4074			1821+	VSCHP	V1, V2, V3, 4, 0	test instruction
000020FE	07FB			1822+	BR	R11	return
00002100				1823+RE42	DS	OF	expected 16 byte result
00002100				1824+	DROP	R5	
00002100	00000000 00000000			1825	DC	XL16' 00000000000000000000000000000000'	
00002108	00000000 00000000			1826	DC	XL16' 0000000000000000000000000000000D'	
00002110	00000000 00000000			1827 * +1			
00002118	00000000 0000000D			1828	VRR_B	VSCHP, 4, 0, 1	
00002120				1829+	DS	OFD	
00002120	00002140	00002120		1830+	USING	*, R5	base for test data and test routine
00002124	002B			1831+T43	DC	A(X43)	address of test routine
00002126	00			1832+	DC	H' 43'	test number
00002127	04			1833+	DC	X' 00'	
00002128	00			1834+	DC	HL1' 4'	m4
00002129	01			1835+	DC	HL1' 0'	m5
00002129	01			1836+V3_43	DC	HL1' 1'	scale
0000212C	00002170			1837+V2_43	DC	A(RE43+16)	address of v2: 16-byte packed decimal
00002130	E5E2C3C8 D7404040			1838+	DC	CL8' VSCHP'	instruction name
00002138	00000010			1839+	DC	A(16)	result length
0000213C	00002160			1840+	DC	A(RE43)	address of expected result
00002140				1841+*			
00002140	E710 8F2C 0006	0000112C		1842+X43	DS	OF	
00002146	E320 500C 0014	0000212C		1843+	VL	V1, V1FUDGE	fudge V1
0000214C	E722 0000 0006	00000000		1844+	LGF	R2, V2_43	get v2
00002152	E730 5009 7000	00002129		1845+	VL	V2, 0(R2)	
00002158	E612 3000 4074			1846+	VLEB	V3, V3_43, 7	get v3 scale
00002158	07FB			1847+	VSCHP	V1, V2, V3, 4, 0	test instruction
0000215E				1848+	BR	R11	return
00002160				1849+RE43	DS	OF	expected 16 byte result
00002160				1850+	DROP	R5	
00002160	41A00000 00000000			1851	DC	XL16' 41A00000000000033000000000000000'	
00002168	33000000 00000000			1852	DC	XL16' 00000000000000000000000000000001C'	
00002170	00000000 00000000			1853 * -1			
00002178	00000000 0000001C			1854	VRR_B	VSCHP, 4, 0, 1	
00002180				1855+	DS	OFD	
00002180	000021A0	00002180		1856+	USING	*, R5	base for test data and test routine
00002180	002C			1857+T44	DC	A(X44)	address of test routine
00002184	00			1858+	DC	H' 44'	test number
00002186	04			1859+	DC	X' 00'	
00002187	00			1860+	DC	HL1' 4'	m4
00002188	01			1861+	DC	HL1' 0'	m5
00002189	000021D0			1862+V3_44	DC	HL1' 1'	scale
0000218C	E5E2C3C8 D7404040			1863+V2_44	DC	A(RE44+16)	address of v2: 16-byte packed decimal
00002190	00000010			1864+	DC	CL8' VSCHP'	instruction name
00002198	00000000			1865+	DC	A(16)	result length
0000219C	000021C0			1866+	DC	A(RE44)	address of expected result
0000219C	1867+*						
000021A0	E710 8F2C 0006	0000112C		1868+X44	DS	OF	
000021A0	0000218C			1869+	VL	V1, V1FUDGE	fudge V1
000021A6	E320 500C 0014	0000218C		1870+	LGF	R2, V2_44	get v2
000021AC	E722 0000 0006	00000000		1871+	VL	V2, 0(R2)	
000021B2	E730 5009 7000	00002189		1872+	VLEB	V3, V3_44, 7	get v3 scale

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
000021B8	E612 3000 4074			1873+ VSCHP V1, V2, V3, 4, 0	test instruction	
000021BE	07FB			1874+ BR R11	return	
000021C0				1875+RE44 DS OF	expected 16 byte result	
000021C0				1876+ DROP R5		
000021C0	C1A00000 00000000			1877 DC XL16' C1A0000000000000B3000000000000000'		
000021C8	B3000000 00000000			1878 DC XL16' 00000000000000000000000000000001D'		
000021D0	00000000 00000000			1879		
000021D8	00000000 0000001D			1880 * +9000000000000001		
				1881 VRR_B VSCHP, 4, 0, 2		
000021E0				1882+ DS OFD		
000021E0	00002200	000021E0		1883+ USING *, R5	base for test data and test routine	
000021E0	002D			1884+T45 DC A(X45)	address of test routine	
000021E4	00			1885+ DC H' 45'	test number	
000021E6	00			1886+ DC X' 00'		
000021E7	04			1887+ DC HL1' 4'	m4	
000021E8	00			1888+ DC HL1' 0'	m5	
000021E9	02			1889+V3_45 DC HL1' 2'	scale	
000021EC	00002230			1890+V2_45 DC A(RE45+16)	address of v2: 16-byte packed decimal	
000021F0	E5E2C3C8 D7404040			1891+ DC CL8' VSCHP'	instruction name	
000021F8	00000010			1892+ DC A(16)	result length	
000021FC	00002220			1893+ DC A(RE45)	address of expected result	
00002200				1894+*		
00002200	E710 8F2C 0006	0000112C		1895+X45 DS OF		
00002206	E320 500C 0014	000021EC		1896+ VL V1, V1FUDGE	fudge V1	
0000220C	E722 0000 0006	00000000		1897+ LGF R2, V2_45	get v2	
00002212	E730 5009 7000	000021E9		1898+ VL V2, 0(R2)		
				1899+ VLEB V3, V3_45, 7	get v3 scale	
00002218	E612 3000 4074			1900+ VSCHP V1, V2, V3, 4, 0	test instruction	
0000221E	07FB			1901+ BR R11	return	
00002220				1902+RE45 DS OF	expected 16 byte result	
00002220	4FC7D713 B49DA006			1903+ DROP R5		
00002228	41400000 00000000			1904 DC XL16' 4FC7D713B49DA00641400000000000000'		
00002230	00000000 00000009			1905 DC XL16' 00000000000000090000000000000001C'		
00002238	00000000 0000001C			1906		
				1907 * - 9223372036854775808		
				1908 VRR_B VSCHP, 4, 0, 2		
00002240				1909+ DS OFD		
00002240	00002260	00002240		1910+ USING *, R5	base for test data and test routine	
00002240	002E			1911+T46 DC A(X46)	address of test routine	
00002244	00			1912+ DC H' 46'	test number	
00002246	00			1913+ DC X' 00'		
00002247	04			1914+ DC HL1' 4'	m4	
00002248	00			1915+ DC HL1' 0'	m5	
00002249	02			1916+V3_46 DC HL1' 2'	scale	
0000224C	00002290			1917+V2_46 DC A(RE46+16)	address of v2: 16-byte packed decimal	
00002250	E5E2C3C8 D7404040			1918+ DC CL8' VSCHP'	instruction name	
00002258	00000010			1919+ DC A(16)	result length	
0000225C	00002280			1920+ DC A(RE46)	address of expected result	
00002260	E710 8F2C 0006	0000112C		1922+X46 DS OF		
00002260	E320 500C 0014	0000224C	1923+ VL V1, V1FUDGE	fudge V1		
00002266			1924+ LGF R2, V2_46	get v2		

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
0000226C	E722 0000 0006		00000000	1925+	VL	V2, 0(R2)	
00002272	E730 5009 7000		00002249	1926+	VLEB	V3, V3_46, 7	get v3 scale
00002278	E612 3000 4074			1927+	VSCHP	V1, V2, V3, 4, 0	test instruction
0000227E	07FB			1928+	BR	R11	return
00002280				1929+RE46	DS	OF	expected 16 byte result
00002280				1930+	DROP	R5	
00002280	D2320000 00000000			1931	DC	XL16' D2320000000000000C4000000000000000'	
00002288	C4000000 00000000						
00002290	00000000 00009223			1932	DC	XL16' 0000000000009223372036854775808D'	
00002298	37203685 4775808D			1933			
				1934 *	9223372036854775807		
				1935	VRR_B	VSCHP, 4, 0, 2	
000022A0		000022A0		1936+	DS	OFD	
000022A0				1937+	USING	*, R5	base for test data and test routine
000022A0	000022C0			1938+T47	DC	A(X47)	address of test routine
000022A4	002F			1939+	DC	H' 47'	test number
000022A6	00			1940+	DC	X' 00'	
000022A7	04			1941+	DC	HL1' 4'	m4
000022A8	00			1942+	DC	HL1' 0'	m5
000022A9	02			1943+V3_47	DC	HL1' 2'	scale
000022AC	000022F0			1944+V2_47	DC	A(RE47+16)	address of v2: 16-byte packed decimal
000022B0	E5E2C3C8 D7404040			1945+	DC	CL8' VSCHP'	instruction name
000022B8	00000010			1946+	DC	A(16)	result length
000022BC	000022E0			1947+	DC	A(RE47)	address of expected result
000022C0				1948+*			
000022C0	E710 8F2C 0006	0000112C		1949+X47	DS	OF	
000022C6	E320 500C 0014	000022AC		1950+	VL	V1, V1FUDGE	fudge V1
000022CC	E722 0000 0006	00000000		1951+	LGF	R2, V2_47	get v2
000022D2	E730 5009 7000	000022A9		1952+	VL	V2, 0(R2)	
000022D8	E612 3000 4074			1953+	VLEB	V3, V3_47, 7	get v3 scale
000022DE	07FB			1954+	VSCHP	V1, V2, V3, 4, 0	test instruction
000022E0				1955+	BR	R11	return
000022E0				1956+RE47	DS	OF	expected 16 byte result
000022E0	5231FFFF FFFFFFFF			1957+	DROP	R5	
000022E8	44FF9C00 00000000			1958	DC	XL16' 5231FFFFFFFFFFFF44FF9C000000000000'	
000022F0	00000000 00009223			1959	DC	XL16' 0000000000009223372036854775807C'	
000022F8	37203685 4775807C			1960			
				1961 *	18446744073709551615		
00002300		00002300		1962	VRR_B	VSCHP, 4, 0, 2	
00002300				1963+	DS	OFD	
00002300	00002320			1964+	USING	*, R5	base for test data and test routine
00002304	0030			1965+T48	DC	A(X48)	address of test routine
00002306	00			1966+	DC	H' 48'	test number
00002307	04			1967+	DC	X' 00'	
00002308	00			1968+	DC	HL1' 4'	m4
00002309	02			1969+	DC	HL1' 0'	m5
0000230C	00002350			1970+V3_48	DC	HL1' 2'	scale
00002310	E5E2C3C8 D7404040			1971+V2_48	DC	A(RE48+16)	address of v2: 16-byte packed decimal
00002318	00000010			1972+	DC	CL8' VSCHP'	instruction name
0000231C	00002340			1973+	DC	A(16)	result length
00002320				1974+	DC	A(RE48)	address of expected result
				1975+*			
				1976+X48	DS	OF	

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
00002489	00			2081+V3_52	DC	HL1' 0'
0000248C	000024D0			2082+V2_52	DC	A(RE52+16)
00002490	E5E2C3C8 D7404040			2083+	DC	CL8' VSCHP'
00002498	00000010			2084+	DC	A(16)
0000249C	000024C0			2085+	DC	A(RE52)
				2086+*		scale
000024A0				2087+X52	DS	OF
000024A0	E710 8F2C 0006	0000112C	2088+	VL	V1, V1FUDGE	fudge V1
000024A6	E320 500C 0014	0000248C	2089+	LGF	R2, V2_52	get v2
000024AC	E722 0000 0006	00000000	2090+	VL	V2, 0(R2)	
000024B2	E730 5009 7000	00002489	2091+	VLEB	V3, V3_52, 7	get v3 scale
000024B8	E612 3010 2074		2092+	VSCHP	V1, V2, V3, 2, 1	test instruction
000024BE	07FB		2093+	BR	R11	return
000024C0			2094+RE52	DS	OF	expected 16 byte result
000024C0			2095+	DROP	R5	
000024C0	C1100000 00000000		2096	DC	XL16' C11000000000000000000000000000000'	
000024C8	00000000 00000000					
000024D0	00000000 00000000		2097	DC	XL16' 00000000000000000000000000000001D'	
000024D8	00000000 0000001D			2098		
				2099 * +9000000000000001		
				2100	VRR_B	VSCHP, 2, 1, 0
000024E0		000024E0	2101+	DS	OFD	
000024E0			2102+	USING	*, R5	base for test data and test routine
000024E0	00002500		2103+T53	DC	A(X53)	address of test routine
000024E4	0035		2104+	DC	H' 53'	test number
000024E6	00		2105+	DC	X' 00'	
000024E7	02		2106+	DC	HL1' 2'	m4
000024E8	01		2107+	DC	HL1' 1'	m5
000024E9	00		2108+V3_53	DC	HL1' 0'	scale
000024EC	00002530		2109+V2_53	DC	A(RE53+16)	address of v2: 16-byte packed decimal
000024F0	E5E2C3C8 D7404040		2110+	DC	CL8' VSCHP'	instruction name
000024F8	00000010		2111+	DC	A(16)	result length
000024FC	00002520		2112+	DC	A(RE53)	address of expected result
			2113+*			
00002500			2114+X53	DS	OF	
00002500	E710 8F2C 0006	0000112C	2115+	VL	V1, V1FUDGE	fudge V1
00002506	E320 500C 0014	000024EC	2116+	LGF	R2, V2_53	get v2
0000250C	E722 0000 0006	00000000	2117+	VL	V2, 0(R2)	
00002512	E730 5009 7000	000024E9	2118+	VLEB	V3, V3_53, 7	get v3 scale
00002518	E612 3010 2074		2119+	VSCHP	V1, V2, V3, 2, 1	test instruction
0000251E	07FB		2120+	BR	R11	return
00002520			2121+RE53	DS	OF	expected 16 byte result
00002520			2122+	DROP	R5	
00002520	4E1FF974 00000000		2123	DC	XL16' 4E1FF974000000000000000000000000'	
00002528	00000000 00000000					
00002530	00000000 00000009		2124	DC	XL16' 00000000000000009000000000000001C'	
00002538	00000000 0000001C			2125		
				2126 * -9223372036854775808		
00002540		00002540	2127	VRR_B	VSCHP, 2, 1, 0	
00002540			2128+	DS	OFD	
00002540	00002560		2129+	USING	*, R5	base for test data and test routine
00002544	0036		2130+T54	DC	A(X54)	address of test routine
00002546	00		2131+	DC	H' 54'	test number
			2132+	DC	X' 00'	

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
00002547	02			2133+	DC	HL1' 2'
00002548	01			2134+	DC	HL1' 1'
00002549	00			2135+V3_54	DC	HL1' 0'
0000254C	00002590			2136+V2_54	DC	A(RE54+16)
00002550	E5E2C3C8 D7404040			2137+	DC	CL8' VSCHP'
00002558	00000010			2138+	DC	A(16)
0000255C	00002580			2139+	DC	A(RE54)
				2140+*		
00002560				2141+X54	DS	OF
00002560	E710 8F2C 0006	0000112C		2142+	VL	V1, V1FUDGE
00002566	E320 500C 0014	0000254C		2143+	LGF	R2, V2_54
0000256C	E722 0000 0006	00000000		2144+	VL	V2, 0(R2)
00002572	E730 5009 7000	00002549		2145+	VLEB	V3, V3_54, 7
00002578	E612 3010 2074			2146+	VSCHP	V1, V2, V3, 2, 1
0000257E	07FB			2147+	BR	R11
00002580				2148+RE54	DS	OF
00002580				2149+	DROP	R5
00002580	D0800000 00000000			2150	DC	XL16' D08000000000000000000000000000000'
00002588	00000000 00000000			2151	DC	XL16' 0000000000009223372036854775808D'
00002590	00000000 00009223					
00002598	37203685 4775808D			2152		
				2153 * 9223372036854775807		
000025A0		000025A0		2154		VRR_B VSCHP, 2, 1, 0
000025A0				2155+	DS	OFD
000025A0	000025C0			2156+	USING	*, R5
000025A4	0037			2157+T55	DC	A(X55)
000025A6	00			2158+	DC	H' 55'
000025A7	02			2159+	DC	X' 00'
000025A8	01			2160+	DC	HL1' 2'
000025A9	00			2161+	DC	HL1' 1'
000025AC	000025F0			2162+V3_55	DC	HL1' 0'
000025B0	E5E2C3C8 D7404040			2163+V2_55	DC	A(RE55+16)
000025B8	00000010			2164+	DC	CL8' VSCHP'
000025BC	000025E0			2165+	DC	A(16)
				2166+	DC	A(RE55)
				2167+*		
000025C0				2168+X55	DS	OF
000025C0	E710 8F2C 0006	0000112C		2169+	VL	V1, V1FUDGE
000025C6	E320 500C 0014	000025AC		2170+	LGF	R2, V2_55
000025CC	E722 0000 0006	00000000		2171+	VL	V2, 0(R2)
000025D2	E730 5009 7000	000025A9		2172+	VLEB	V3, V3_55, 7
000025D8	E612 3010 2074			2173+	VSCHP	V1, V2, V3, 2, 1
000025DE	07FB			2174+	BR	R11
000025E0				2175+RE55	DS	OF
000025E0				2176+	DROP	R5
000025E0	50800000 00000000			2177	DC	XL16' 50800000000000000000000000000000'
000025E8	00000000 00000000			2178	DC	XL16' 0000000000009223372036854775807C'
000025F0	00000000 00009223					
000025F8	37203685 4775807C					
				2179		
				2180 * 18446744073709551615		
00002600		00002600		2181		VRR_B VSCHP, 2, 1, 0
00002600				2182+	DS	OFD
00002600	00002620			2183+	USING	*, R5
				2184+T56	DC	A(X56)
						base for test data and test routine
						address of test routine

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
000026C0				2237 2238+	VRR_B VSCHP, 3, 1, 0 DS OFD	
000026C0		000026C0		2239+ 2240+T58 2241+	USING *, R5 DC A(X58) DC H' 58'	base for test data and test routine address of test routine test number
000026C4	003A			2242+ 2243+ 2244+	DC X' 00' DC HL1' 3' DC HL1' 1'	m4 m5
000026C6	00			2245+V3_58	DC HL1' 0'	scale
000026C7	03			2246+V2_58	DC A(RE58+16)	address of v2: 16-byte packed decimal
000026C8	01			2247+	DC CL8' VSCHP'	instruction name
000026C9	00			2248+ 2249+	DC A(16) DC A(RE58)	result length address of expected result
000026D0	E5E2C3C8 D7404040			2250+*		
000026D8	00000010			2251+X58	DS OF	
000026DC	00002700			2252+ 2253+ 2254+ 2255+ 2256+	VL V1, V1FUDGE LGF R2, V2_58 VL V2, 0(R2) VLEB V3, V3_58, 7 VSCHP V1, V2, V3, 3, 1	fudge V1 get v2
000026E0	E710 8F2C 0006	0000112C		2257+	BR R11	return
000026E6	E320 500C 0014	000026CC		2258+RE58 2259+	DS OF DROP R5	expected 16 byte result
000026EC	E722 0000 0006	00000000		2260	DC XL16' 00000000000000000000000000000000'	
000026F2	E730 5009 7000	000026C9		2261	DC XL16' 00000000000000000000000000000000D'	
000026F8	E612 3010 3074			2262 * +1 2263	VRR_B VSCHP, 3, 1, 0	
00002700	00000000 00000000			2264+	DS OFD	
00002708	00000000 00000000			2265+ 2266+T59	USING *, R5 DC A(X59)	base for test data and test routine address of test routine test number
00002710	00000000 00000000			2267+ 2268+ 2269+	DC H' 59' DC X' 00' DC HL1' 3'	m4
00002718	00000000 0000000D			2270+ 2271+V3_59 2272+V2_59	DC HL1' 1' DC HL1' 0' DC A(RE59+16)	m5 scale address of v2: 16-byte packed decimal
00002720	00002740	00002720		2273+ 2274+ 2275+	DC CL8' VSCHP' DC A(16) DC A(RE59)	instruction name result length address of expected result
00002724	003B			2276+*		
00002726	00			2277+X59	DS OF	
00002727	03			2278+	VL V1, V1FUDGE	fudge V1
00002728	01			2279+	LGF R2, V2_59	get v2
00002729	00			2280+ 2281+	VL V2, 0(R2) VLEB V3, V3_59, 7	get v3 scale
0000272C	00002770			2282+ 2283+	VSCHP V1, V2, V3, 3, 1	test instruction
00002730	E5E2C3C8 D7404040			2284+RE59	BR R11 DS OF	return expected 16 byte result
00002738	00000010			2285+	DROP R5	
0000273C	00002760			2286	DC XL16' 41100000000000000000000000000000'	
00002740	E710 8F2C 0006	0000112C		2287	DC XL16' 00000000000000000000000000000001C'	
00002746	E320 500C 0014	0000272C		2288 * - 1		
0000274C	E722 0000 0006	00000000				
00002752	E730 5009 7000	00002729				
00002758	E612 3010 3074					
0000275E	07FB					
00002760	41100000 00000000					
00002768	00000000 00000000					
00002770	00000000 00000000					
00002778	00000000 0000001C					

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
000028F0	00000000 00009223			2394 DC XL16' 0000000000009223372036854775807C'		
000028F8	37203685 4775807C			2395 2396 * 18446744073709551615 2397 VRR_B VSCHP, 3, 1, 0		
00002900				2398+ DS OFD		
00002900		00002900		2399+ USING *, R5	base for test data and test routine	
00002900	00002920			2400+T64 DC A(X64)	address of test routine	
00002904	0040			2401+ DC H' 64'	test number	
00002906	00			2402+ DC X' 00'		
00002907	03			2403+ DC HL1' 3'	m4	
00002908	01			2404+ DC HL1' 1'	m5	
00002909	00			2405+V3_64 DC HL1' 0'	scale	
0000290C	00002950			2406+V2_64 DC A(RE64+16)	address of v2: 16-byte packed decimal	
00002910	E5E2C3C8 D7404040			2407+ DC CL8' VSCHP'	instruction name	
00002918	00000010			2408+ DC A(16)	result length	
0000291C	00002940			2409+ DC A(RE64)	address of expected result	
00002920				2410+*		
00002920	E710 8F2C 0006	0000112C		2411+X64 DS OF		
00002926	E320 500C 0014			2412+ VL V1, V1FUDGE	fudge V1	
0000292C	E722 0000 0006			2413+ LGF R2, V2_64	get v2	
00002932	E730 5009 7000		00002909	2414+ VL V2, 0(R2)		
00002938	E612 3010 3074			2415+ VLEB V3, V3_64, 7	get v3 scale	
0000293E	07FB			2416+ VSCHP V1, V2, V3, 3, 1	test instruction	
00002940				2417+ BR R11	return	
00002940				2418+RE64 DS OF	expected 16 byte result	
00002940				2419+ DROP R5		
00002940	51100000 00000000			2420 DC XL16' 51100000000000000000000000000000'		
00002948	00000000 00000000					
00002950	00000000 00018446			2421 DC XL16' 000000000018446744073709551615C'		
00002958	74407370 9551615C					
00002960				2422		
00002960		00002960		2423 * 9009000000018446744073709551615		
00002960	00002980			2424 VRR_B VSCHP, 3, 1, 0		
00002964	0041			2425+ DS OFD		
00002966	00			2426+ USING *, R5	base for test data and test routine	
00002967	03			2427+T65 DC A(X65)	address of test routine	
00002968	01			2428+ DC H' 65'	test number	
00002969	00			2429+ DC X' 00'		
0000296C	000029B0			2430+ DC HL1' 3'	m4	
00002970	E5E2C3C8 D7404040			2431+ DC HL1' 1'	m5	
00002978	00000010			2432+V3_65 DC HL1' 0'	scale	
0000297C	000029A0			2433+V2_65 DC A(RE65+16)	address of v2: 16-byte packed decimal	
00002980				2434+ DC CL8' VSCHP'	instruction name	
00002980	E710 8F2C 0006	0000112C		2435+ DC A(16)	result length	
00002986	E320 500C 0014	0000296C		2436+ DC A(RE65)	address of expected result	
0000298C	E722 0000 0006		00000000	2437+*		
00002992	E730 5009 7000		00002969	2438+X65 DS OF		
00002998	E612 3010 3074			2439+ VL V1, V1FUDGE	fudge V1	
0000299E	07FB			2440+ LGF R2, V2_65	get v2	
000029A0				2441+ VL V2, 0(R2)		
000029A0				2442+ VLEB V3, V3_65, 7	get v3 scale	
000029A0				2443+ VSCHP V1, V2, V3, 3, 1	test instruction	
000029A0				2444+ BR R11	return	
000029A0				2445+RE65 DS OF	expected 16 byte result	
000029A0				2446+ DROP R5		

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
000029A0	5A71B5A6 23751871			2447	DC	XL16' 5A71B5A6237518710000000000000000'
000029A8	00000000 00000000			2448	DC	XL16' 9009000000018446744073709551615C'
000029B0	90090000 00018446			2449		
000029B8	74407370 9551615C			2450	*	9999999990018446744073709551615
000029C0				2451	VRR_B VSCHP, 3, 1, 0	
000029C0	000029E0	000029C0		2452+	DS	OFD
000029C4	0042			2453+	USING	*, R5
000029C6	00			2454+T66	DC	A(X66)
000029C7	03			2455+	DC	H' 66'
000029C8	01			2456+	DC	X' 00'
000029C9	00			2457+	DC	HL1' 3'
000029CC	00002A10			2458+	DC	HL1' 1'
000029D0	E5E2C3C8 D7404040			2459+V3_66	DC	HL1' 0'
000029D8	00000010			2460+V2_66	DC	A(RE66+16)
000029DC	00002A00			2461+	DC	CL8' VSCHP'
000029E0				2462+	DC	A(16)
000029E6	E710 8F2C 0006	0000112C		2463+	DC	A(RE66)
000029EC	E320 500C 0014	000029CC		2464+*		
000029F2	E722 0000 0006	00000000		2465+X66	DS	OF
000029F8	E730 5009 7000	000029C9		2466+	VL	V1, V1FUDGE
000029FE	E612 3010 3074			2467+	LGF	R2, V2_66
00002A00	07FB			2468+	VL	V2, 0(R2)
00002A00				2469+	VLEB	V3, V3_66, 7
00002A10	5A7E37BE 1E05A6B1			2470+	VSCHP	V1, V2, V3, 3, 1
00002A18	00000000 00000000			2471+	BR	R11
00002A18	99999999 90018446			2472+RE66	DS	OF
00002A18	74407370 9551615C			2473+	DROP	R5
00002A20				2474	DC	XL16' 5A7E37BE1E05A6B1000000000000000'
00002A20				2475	DC	XL16' 9999999990018446744073709551615C'
00002A20	00002A40	00002A20		2476	*	
00002A24	0043			2477	*	extended float
00002A26	00			2478	*	
00002A27	04			2479	*	+0
00002A28	01			2480	VRR_B VSCHP, 4, 1, 0	
00002A29	00			2481+	DS	OFD
00002A2C	00002A70			2482+	USING	*, R5
00002A30	E5E2C3C8 D7404040			2483+T67	DC	A(X67)
00002A38	00000010			2484+	DC	H' 67'
00002A3C	00002A60			2485+	DC	X' 00'
00002A40				2486+	DC	HL1' 4'
00002A40	E710 8F2C 0006	0000112C		2487+	DC	HL1' 1'
00002A46	E320 500C 0014	00002A2C		2488+V3_67	DC	HL1' 0'
00002A4C	E722 0000 0006	00000000		2489+V2_67	DC	A(RE67+16)
00002A52	E730 5009 7000	00002A29		2490+	DC	CL8' VSCHP'
00002A52				2491+	DC	A(16)
00002A52				2492+	DC	A(RE67)
00002A52				2493+*		
00002A52				2494+X67	DS	OF
00002A52				2495+	VL	V1, V1FUDGE
00002A52				2496+	LGF	R2, V2_67
00002A52				2497+	VL	V2, 0(R2)
00002A52				2498+	VLEB	V3, V3_67, 7
00002A52						get v3 scale

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
00002A58	E612 3010 4074			2499+ VSCHP V1, V2, V3, 4, 1	test instruction	
00002A5E	07FB			2500+ BR R11	return	
00002A60				2501+RE67 DS OF	expected 16 byte result	
00002A60				2502+ DROP R5		
00002A60	00000000 00000000			2503 DC XL16' 00000000000000000000000000000000'		
00002A68	00000000 00000000			2504 DC XL16' 00000000000000000000000000000000C'		
00002A78	00000000 0000000C			2505 * -0		
00002A80				2506 VRR_B VSCHP, 4, 1, 0		
00002A80				2507+ DS OFD		
00002A80	00002AA0	00002A80		2508+ USING *, R5	base for test data and test routine	
00002A84	0044			2509+T68 DC A(X68)	address of test routine	
00002A86	00			2510+ DC H'68'	test number	
00002A87	04			2511+ DC X'00'		
00002A88	01			2512+ DC HL1'4'	m4	
00002A89	00			2513+ DC HL1'1'	m5	
00002A8C	00002AD0			2514+V3_68 DC HL1'0'	scale	
00002A90	E5E2C3C8 D7404040			2515+V2_68 DC A(RE68+16)	address of v2: 16-byte packed decimal	
00002A98	00000010			2516+ DC CL8'VSCHP'	instruction name	
00002A9C	00002AC0			2517+ DC A(16)	result length	
				2518+ DC A(RE68)	address of expected result	
				2519+*		
00002AA0				2520+X68 DS OF		
00002AA0	E710 8F2C 0006	0000112C		2521+ VL V1, V1FUDGE	fudge V1	
00002AA6	E320 500C 0014	00002A8C		2522+ LGF R2, V2_68	get v2	
00002AAC	E722 0000 0006	00000000		2523+ VL V2, 0(R2)		
00002AB2	E730 5009 7000	00002A89		2524+ VLEB V3, V3_68, 7	get v3 scale	
00002AB8	E612 3010 4074			2525+ VSCHP V1, V2, V3, 4, 1	test instruction	
00002ABE	07FB			2526+ BR R11	return	
00002AC0				2527+RE68 DS OF	expected 16 byte result	
00002AC0				2528+ DROP R5		
00002AC0	00000000 00000000			2529 DC XL16' 00000000000000000000000000000000'		
00002AC8	00000000 00000000			2530 DC XL16' 00000000000000000000000000000000D'		
00002AD0	00000000 00000000			2531 * +1		
00002AD8	00000000 0000000D			2532 VRR_B VSCHP, 4, 1, 0		
00002AE0				2533+ DS OFD		
00002AE0				2534+ USING *, R5	base for test data and test routine	
00002AE0	00002B00	00002AE0		2535+T69 DC A(X69)	address of test routine	
00002AE4	0045			2536+ DC H'69'	test number	
00002AE6	00			2537+ DC X'00'		
00002AE7	04			2538+ DC HL1'4'	m4	
00002AE8	01			2539+ DC HL1'1'	m5	
00002AE9	00			2540+V3_69 DC HL1'0'	scale	
00002AEC	00002B30			2541+V2_69 DC A(RE69+16)	address of v2: 16-byte packed decimal	
00002AF0	E5E2C3C8 D7404040			2542+ DC CL8'VSCHP'	instruction name	
00002AF8	00000010			2543+ DC A(16)	result length	
00002AFC	00002B20			2544+ DC A(RE69)	address of expected result	
				2545+*		
00002B00				2546+X69 DS OF		
00002B00	E710 8F2C 0006	0000112C		2547+ VL V1, V1FUDGE	fudge V1	
00002B06	E320 500C 0014	00002AEC		2548+ LGF R2, V2_69	get v2	
00002B0C	E722 0000 0006	00000000		2549+ VL V2, 0(R2)		
00002B12	E730 5009 7000	00002AE9		2550+ VLEB V3, V3_69, 7	get v3 scale	

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
00002B18	E612 3010 4074			2551+ VSCHP V1, V2, V3, 4, 1	test instruction	
00002B1E	07FB			2552+ BR R11	return	
00002B20				2553+RE69 DS OF	expected 16 byte result	
00002B20				2554+ DROP R5		
00002B20	41100000 00000000			2555 DC XL16' 41100000000000003300000000000000'		
00002B28	33000000 00000000			2556 DC XL16' 00000000000000000000000000000001C'		
00002B30	00000000 00000000			2557 * - 1		
00002B38	00000000 0000001C			2558 VRR_B VSCHP, 4, 1, 0		
00002B40				2559+ DS OFD		
00002B40	00002B60	00002B40		2560+ USING *, R5	base for test data and test routine	
00002B44	0046			2561+T70 DC A(X70)	address of test routine	
00002B46	00			2562+ DC H' 70'	test number	
00002B47	04			2563+ DC X' 00'		
00002B48	01			2564+ DC HL1' 4'	m4	
00002B49	00			2565+ DC HL1' 1'	m5	
00002B4C	00002B90			2566+V3_70 DC HL1' 0'	scale	
00002B50	E5E2C3C8 D7404040			2567+V2_70 DC A(RE70+16)	address of v2: 16-byte packed decimal	
00002B58	00000010			2568+ DC CL8' VSCHP'	instruction name	
00002B5C	00002B80			2569+ DC A(16)	result length	
				2570+ DC A(RE70)	address of expected result	
				2571+*		
00002B60				2572+X70 DS OF		
00002B60	E710 8F2C 0006	0000112C		2573+ VL V1, V1FUDGE	fudge V1	
00002B66	E320 500C 0014	00002B4C		2574+ LGF R2, V2_70	get v2	
00002B6C	E722 0000 0006	00000000		2575+ VL V2, 0(R2)		
00002B72	E730 5009 7000	00002B49		2576+ VLEB V3, V3_70, 7	get v3 scale	
00002B78	E612 3010 4074			2577+ VSCHP V1, V2, V3, 4, 1	test instruction	
00002B7E	07FB			2578+ BR R11	return	
00002B80				2579+RE70 DS OF	expected 16 byte result	
00002B80				2580+ DROP R5		
00002B80	C1100000 00000000			2581 DC XL16' C1100000000000000B3000000000000000'		
00002B88	B3000000 00000000			2582 DC XL16' 00000000000000000000000000000001D'		
00002B90	00000000 00000000			2583		
00002B98	00000000 0000001D			2584 * +9000000000000001		
00002BA0				2585 VRR_B VSCHP, 4, 1, 0		
00002BA0	00002BC0	00002BA0		2586+ DS OFD		
00002BA0	0047			2587+ USING *, R5	base for test data and test routine	
00002BA4	0047			2588+T71 DC A(X71)	address of test routine	
00002BA6	00			2589+ DC H' 71'	test number	
00002BA7	04			2590+ DC X' 00'		
00002BA8	01			2591+ DC HL1' 4'	m4	
00002BA9	00			2592+ DC HL1' 1'	m5	
00002BAC	00002BF0			2593+V3_71 DC HL1' 0'	scale	
00002BB0	E5E2C3C8 D7404040			2594+V2_71 DC A(RE71+16)	address of v2: 16-byte packed decimal	
00002BB8	00000010			2595+ DC CL8' VSCHP'	instruction name	
00002BBC	00002BE0			2596+ DC A(16)	result length	
				2597+ DC A(RE71)	address of expected result	
				2598+*		
00002BC0				2599+X71 DS OF		
00002BC0	E710 8F2C 0006	0000112C		2600+ VL V1, V1FUDGE	fudge V1	
00002BC6	E320 500C 0014	00002BAC		2601+ LGF R2, V2_71	get v2	
00002BCC	E722 0000 0006	00000000		2602+ VL V2, 0(R2)		

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00002BD2	E730 5009 7000		00002BA9	2603+ 2604+ 2605+ 2606+RE71 2607+	VLEB VSCHP BR DS DROP	V3, V3_71, 7 V1, V2, V3, 4, 1 R11 OF R5	get v3 scale test instruction return expected 16 byte result
00002BD8	E612 3010 4074	07FB		2608	DC	XL16' 4E1FF973CAFA800140000000000000000'	
00002BE0	4E1FF973 CAFA8001			2609	DC	XL16' 00000000000000009000000000000001C'	
00002BF8	40000000 00000000			2610 2611 * -9223372036854775808			
00002BF0	00000000 00000009			2612	VRR_B VSCHP, 4, 1, 0		
00002BF8	00000000 0000001C			2613+ 2614+ 2615+T72 2616+ 2617+ 2618+ 2619+ 2620+V3_72	DS USING *, R5 DC DC DC DC DC DC DC	OFD *, R5 A(X72) H' 72' X' 00' HL1' 4' HL1' 1' HL1' 0'	base for test data and test routine address of test routine test number m4 m5 scale address of v2: 16-byte packed decimal instruction name result length address of expected result
00002C00	00002C00	00002C00		2621+V2_72 2622+ 2623+ 2624+ 2625+*	DC DC DC DC	A(RE72+16) CL8' VSCHP' A(16) A(RE72)	
00002C00	00002C20			2626+X72	DS	OF	
00002C04	0048			2627+ 2628+ 2629+	VL LGF VL	V1, V1FUDGE R2, V2_72 V2, 0(R2)	fudge V1 get v2
00002C06	00						
00002C07	04						
00002C08	01						
00002C09	00						
00002C0C	00002C50						
00002C10	E5E2C3C8 D7404040						
00002C18	00000010						
00002C1C	00002C40						
00002C20	E710 8F2C 0006		0000112C				
00002C26	E320 500C 0014		00002C0C				
00002C2C	E722 0000 0006		00000000				
00002C32	E730 5009 7000		00002C09	2630+ 2631+ 2632+ 2633+RE72	VLEB VSCHP BR DS	V3, V3_72, 7 V1, V2, V3, 4, 1 R11 OF	get v3 scale test instruction return expected 16 byte result
00002C38	E612 3010 4074	07FB		2634+ 2635	DROP DC	R5 XL16' D080000000000000C20000000000000'	
00002C40	00			2636	DC	XL16' 0000000000009223372036854775808D'	
00002C40	D0800000 00000000						
00002C48	C2000000 00000000						
00002C50	00000000 00009223						
00002C58	37203685 4775808D						
00002C60	00002C80	00002C60		2637 2638 * 9223372036854775807 2639	VL	V1, V1FUDGE	fudge V1
00002C60	00002C80	00002C60		2640+ 2641+ 2642+T73	DS USING *, R5 DC	OFD A(X73)	base for test data and test routine address of test routine
00002C64	0049			2643+ 2644+ 2645+ 2646+ 2647+V3_73	DC DC DC DC DC	H' 73' X' 00' HL1' 4' HL1' 1' HL1' 0'	test number m4 m5 scale address of v2: 16-byte packed decimal
00002C66	00						
00002C67	04						
00002C68	01						
00002C69	00						
00002C6C	00002CB0						
00002C70	E5E2C3C8 D7404040						
00002C78	00000010						
00002C7C	00002CA0						
00002C80	00002C80	E710 8F2C 0006	0000112C	2651+ 2652+*	DS VL	OF V1, V1FUDGE	address of expected result
00002C80	00002C80	0000112C		2653+X73 2654+			

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00002C86	E320 500C 0014		00002C6C	2655+	LGF	R2, V2_73	get v2
00002C8C	E722 0000 0006		00000000	2656+	VL	V2, 0(R2)	
00002C92	E730 5009 7000		00002C69	2657+	VLEB	V3, V3_73, 7	get v3 scale
00002C98	E612 3010 4074			2658+	VSCHP	V1, V2, V3, 4, 1	test instruction
00002C9E	07FB			2659+	BR	R11	return
00002CA0				2660+RE73	DS	OF	expected 16 byte result
00002CA0				2661+	DROP	R5	
00002CA0	507FFFFF FFFFFFFF			2662	DC	XL16' 507FFFFFFFFFFFF42FF000000000000'	
00002CA8	42FF0000 00000000			2663	DC	XL16' 0000000000009223372036854775807C'	
00002CB0	00000000 00009223						
00002CB8	37203685 4775807C						
				2664			
				2665 * 18446744073709551615			
				2666		VRR_B VSCHP, 4, 1, 0	
00002CC0				2667+	DS	OFD	
00002CC0		00002CC0		2668+	USING	*, R5	base for test data and test routine
00002CC0	00002CE0			2669+T74	DC	A(X74)	address of test routine
00002CC4	004A			2670+	DC	H' 74'	test number
00002CC6	00			2671+	DC	X' 00'	
00002CC7	04			2672+	DC	HL1' 4'	m4
00002CC8	01			2673+	DC	HL1' 1'	m5
00002CC9	00			2674+V3_74	DC	HL1' 0'	scale
00002CCC	00002D10			2675+V2_74	DC	A(RE74+16)	address of v2: 16-byte packed decimal
00002CD0	E5E2C3C8 D7404040			2676+	DC	CL8' VSCHP'	instruction name
00002CD8	00000010			2677+	DC	A(16)	result length
00002CDC	00002D00			2678+	DC	A(RE74)	address of expected result
00002CE0				2679+*			
00002CE0	E710 8F2C 0006		0000112C	2680+X74	DS	OF	
00002CE6	E320 500C 0014		00002CCC	2681+	VL	V1, V1FUDGE	fudge V1
00002CEC	E722 0000 0006		00000000	2682+	LGF	R2, V2_74	get v2
00002CF2	E730 5009 7000		00002CC9	2683+	VL	V2, 0(R2)	
00002CF8	E612 3010 4074			2684+	VLEB	V3, V3_74, 7	get v3 scale
00002CF8	07FB			2685+	VSCHP	V1, V2, V3, 4, 1	test instruction
00002CFE				2686+	BR	R11	return
00002D00				2687+RE74	DS	OF	expected 16 byte result
00002D00				2688+	DROP	R5	
00002D00	50FFFFFF FFFFFFFF			2689	DC	XL16' 50FFFFFFFFFFFF42FF000000000000'	
00002D08	42FF0000 00000000						
00002D10	00000000 00018446			2690	DC	XL16' 00000000000018446744073709551615C'	
00002D18	74407370 9551615C						
				2691			
				2692 * 9009000000018446744073709551615			
				2693		VRR_B VSCHP, 4, 1, 0	
00002D20				2694+	DS	OFD	
00002D20		00002D20		2695+	USING	*, R5	base for test data and test routine
00002D20	00002D40			2696+T75	DC	A(X75)	address of test routine
00002D24	004B			2697+	DC	H' 75'	test number
00002D26	00			2698+	DC	X' 00'	
00002D27	04			2699+	DC	HL1' 4'	m4
00002D28	01			2700+	DC	HL1' 1'	m5
00002D29	00			2701+V3_75	DC	HL1' 0'	scale
00002D2C	00002D70			2702+V2_75	DC	A(RE75+16)	address of v2: 16-byte packed decimal
00002D30	E5E2C3C8 D7404040			2703+	DC	CL8' VSCHP'	instruction name
00002D38	00000010			2704+	DC	A(16)	result length
00002D3C	00002D60			2705+	DC	A(RE75)	address of expected result
				2706+*			

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
00002D40				2707+X75	DS OF	
00002D40	E710 8F2C 0006	0000112C	2708+	VL V1, V1FUDGE	fudge V1	
00002D46	E320 500C 0014	00002D2C	2709+	LGF R2, V2_75	get v2	
00002D4C	E722 0000 0006	00000000	2710+	VL V2, 0(R2)		
00002D52	E730 5009 7000	00002D29	2711+	VLEB V3, V3_75, 7	get v3 scale	
00002D58	E612 3010 4074		2712+	VSCHP V1, V2, V3, 4, 1	test instruction	
00002D5E	07FB		2713+	BR R11	return	
00002D60			2714+RE75	DS OF	expected 16 byte result	
00002D60			2715+	DROP R5		
00002D60	5A71B5A6 23751870		2716	DC XL16' 5A71B5A6237518704CDF6067FFFFF00'		
00002D68	4CDF6067 FFFFFF00					
00002D70	90090000 00018446		2717	DC XL16' 9009000000018446744073709551615C'		
00002D78	74407370 9551615C			2718		
				2719 * 999999990018446744073709551615		
00002D80		00002D80		2720 VRR_B VSCHP, 4, 1, 0		
00002D80	00002DAO		2721+ DS OFD			
00002D84	004C		2722+ USING *, R5	base for test data and test routine		
00002D86	00		2723+T76 DC A(X76)	address of test routine		
00002D87	04		2724+ DC H' 76'	test number		
00002D88	01		2725+ DC X' 00'			
00002D89	00		2726+ DC HL1' 4'	m4		
00002D8C	00002DD0		2727+ DC HL1' 1'	m5		
00002D90	E5E2C3C8 D7404040		2728+V3_76 DC HL1' 0'	scale		
00002D98	00000010		2729+V2_76 DC A(RE76+16)	address of v2: 16-byte packed decimal		
00002D9C	00002DC0		2730+ DC CL8' VSCHP'	instruction name		
			2731+ DC A(16)	result length		
			2732+ DC A(RE76)	address of expected result		
			2733+*			
00002DA0			2734+X76 DS OF			
00002DA0	E710 8F2C 0006	0000112C	2735+ VL V1, V1FUDGE	fudge V1		
00002DA6	E320 500C 0014	00002D8C	2736+ LGF R2, V2_76	get v2		
00002DAC	E722 0000 0006	00000000	2737+ VL V2, 0(R2)			
00002DB2	E730 5009 7000	00002D89	2738+ VLEB V3, V3_76, 7	get v3 scale		
00002DB8	E612 3010 4074		2739+ VSCHP V1, V2, V3, 4, 1	test instruction		
00002DBE	07FB		2740+ BR R11	return		
00002DC0			2741+RE76 DS OF	expected 16 byte result		
00002DC0			2742+ DROP R5			
00002DC0	5A7E37BE 1E05A6B0		2743 DC XL16' 5A7E37BE1E05A6B04C816BCDBFFFFF00'			
00002DC8	4C816BCD BFFFFF00					
00002DD0	99999999 90018446		2744 DC XL16' 999999990018446744073709551615C'			
00002DD8	74407370 9551615C					
			2745			
			2746			
			2747 *-----			
			2748 * ROUND - with shifts			
			2749 *-----			
			2750 *-----			
			2751 * short float			
			2752 *-----			
			2753 * +0			
			2754 VRR_B VSCHP, 2, 1, 1			
00002DE0		00002DE0	2755+ DS OFD			
00002DE0	00002E00		2756+ USING *, R5	base for test data and test routine		
00002DE0	004D		2757+T77 DC A(X77)	address of test routine		
00002DE4			2758+ DC H' 77'	test number		

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
00003020		00003020		2915+ 2916+T83	USING *, R5 DC A(X83)	base for test data and test routine address of test routine
00003020	00003040			2917+ 2918+ 2919+	DC H'83' DC X'00' DC HL1'2'	test number m4
00003024	0053			2920+	DC HL1'1'	m5
00003026	00			2921+V3_83	DC HL1'2'	scale
00003027	02			2922+V2_83	DC A(RE83+16)	address of v2: 16-byte packed decimal
0000302C	00003070			2923+	DC CL8' VSCHP'	instruction name
00003030	E5E2C3C8 D7404040			2924+	DC A(16)	result length
00003038	00000010			2925+	DC A(RE83)	address of expected result
0000303C	00003060			2926+*		
00003040				2927+X83	DS OF	
00003040	E710 8F2C 0006	0000112C		2928+	VL V1, V1FUDGE	fudge V1
00003046	E320 500C 0014	0000302C		2929+	LGF R2, V2_83	get v2
0000304C	E722 0000 0006	00000000		2930+	VL V2, 0(R2)	
00003052	E730 5009 7000	00003029		2931+	VLEB V3, V3_83, 7	get v3 scale
00003058	E612 3010 2074			2932+	VSCHP V1, V2, V3, 2, 1	test instruction
0000305E	07FB			2933+	BR R11	return
00003060				2934+RE83	DS OF	expected 16 byte result
00003060	52320000 00000000			2935+	DROP R5	
00003068	00000000 00000000			2936	DC XL16' 52320000000000000000000000000000'	
00003070	00000000 00009223			2937	DC XL16' 0000000000009223372036854775807C'	
00003078	37203685 4775807C			2938		
				2939 *	18446744073709551615	
				2940	VRR_B VSCHP, 2, 1, 2	
00003080		00003080		2941+	DS OFD	
00003080	000030A0			2942+	USING *, R5	base for test data and test routine
00003084	0054			2943+T84	DC A(X84)	address of test routine
00003086	00			2944+	DC H'84'	test number
00003087	02			2945+	DC X'00'	
00003088	01			2946+	DC HL1'2'	m4
00003089	02			2947+	DC HL1'1'	m5
0000308C	000030D0			2948+V3_84	DC HL1'2'	scale
00003090	E5E2C3C8 D7404040			2949+V2_84	DC A(RE84+16)	address of v2: 16-byte packed decimal
00003098	00000010			2950+	DC CL8' VSCHP'	instruction name
0000309C	000030C0			2951+	DC A(16)	result length
				2952+	DC A(RE84)	address of expected result
000030A0				2953+*		
000030A0	E710 8F2C 0006	0000112C		2954+X84	DS OF	
000030A6	E320 500C 0014	0000308C		2955+	VL V1, V1FUDGE	fudge V1
000030AC	E722 0000 0006	00000000		2956+	LGF R2, V2_84	get v2
000030B2	E730 5009 7000	00003089		2957+	VL V2, 0(R2)	
000030B8	E612 3010 2074			2958+	VLEB V3, V3_84, 7	get v3 scale
000030BE	07FB			2959+	VSCHP V1, V2, V3, 2, 1	test instruction
000030C0				2960+	BR R11	return
000030C0				2961+RE84	DS OF	expected 16 byte result
000030C0	52640000 00000000			2962+	DROP R5	
000030C8	00000000 00000000			2963	DC XL16' 52640000000000000000000000000000'	
000030D0	00000000 00018446			2964	DC XL16' 00000000000018446744073709551615C'	
000030D8	74407370 9551615C			2965		
				2966 *		

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
				2967 * long float		
				2968 *		
				2969 * +0		
				2970 VRR_B VSCHP, 3, 1, 1		
				2971+ DS OFD		
000030E0				2972+ USING *, R5	base for test data and test routine	
000030E0	00003100	000030E0		2973+T85 DC A(X85)	address of test routine	
000030E4	0055			2974+ DC H'85'	test number	
000030E6	00			2975+ DC X'00'		
000030E7	03			2976+ DC HL1'3'	m4	
000030E8	01			2977+ DC HL1'1'	m5	
000030E9	01			2978+V3_85 DC HL1'1'	scale	
000030EC	00003130			2979+V2_85 DC A(RE85+16)	address of v2: 16-byte packed decimal	
000030F0	E5E2C3C8 D7404040			2980+ DC CL8'VSCHP'	instruction name	
000030F8	00000010			2981+ DC A(16)	result length	
000030FC	00003120			2982+ DC A(RE85)	address of expected result	
				2983+*		
00003100				2984+X85 DS OF		
00003100	E710 8F2C 0006	0000112C		2985+ VL V1, V1FUDGE	fudge V1	
00003106	E320 500C 0014	000030EC		2986+ LGF R2, V2_85	get v2	
0000310C	E722 0000 0006	00000000		2987+ VL V2, 0(R2)		
00003112	E730 5009 7000	000030E9		2988+ VLEB V3, V3_85, 7	get v3 scale	
00003118	E612 3010 3074			2989+ VSCHP V1, V2, V3, 3, 1	test instruction	
0000311E	07FB			2990+ BR R11	return	
00003120				2991+RE85 DS OF	expected 16 byte result	
00003120				2992+ DROP R5		
00003120	00000000 00000000			2993 DC XL16' 00000000000000000000000000000000'		
00003128	00000000 00000000			2994 DC XL16' 00000000000000000000000000000000C'		
00003138	00000000 0000000C			2995 * -0		
				2996 VRR_B VSCHP, 3, 1, 1		
00003140				2997+ DS OFD		
00003140	00003140	00003140		2998+ USING *, R5	base for test data and test routine	
00003140	00003160			2999+T86 DC A(X86)	address of test routine	
00003144	0056			3000+ DC H'86'	test number	
00003146	00			3001+ DC X'00'		
00003147	03			3002+ DC HL1'3'	m4	
00003148	01			3003+ DC HL1'1'	m5	
00003149	01			3004+V3_86 DC HL1'1'	scale	
0000314C	00003190			3005+V2_86 DC A(RE86+16)	address of v2: 16-byte packed decimal	
00003150	E5E2C3C8 D7404040			3006+ DC CL8'VSCHP'	instruction name	
00003158	00000010			3007+ DC A(16)	result length	
0000315C	00003180			3008+ DC A(RE86)	address of expected result	
				3009+*		
00003160				3010+X86 DS OF		
00003160	E710 8F2C 0006	0000112C	3011+	VL V1, V1FUDGE	fudge V1	
00003166	E320 500C 0014	0000314C	3012+	LGF R2, V2_86	get v2	
0000316C	E722 0000 0006	00000000	3013+	VL V2, 0(R2)		
00003172	E730 5009 7000	00003149	3014+	VLEB V3, V3_86, 7	get v3 scale	
00003178	E612 3010 3074		3015+	VSCHP V1, V2, V3, 3, 1	test instruction	
0000317E	07FB		3016+	BR R11	return	
00003180			3017+RE86 DS OF	expected 16 byte result		
00003180	00000000 00000000		3018+ DROP R5			
00003180	00000000 00000000		3019 DC XL16' 00000000000000000000000000000000'			
00003188	00000000 00000000					

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
00003190	00000000 00000000			3020	DC	XL16' 00000000000000000000000000000000D'
00003198	00000000 0000000D			3021 * +1		
000031A0				3022	VRR_B	VSCHP, 3, 1, 1
000031A0	000031C0	000031A0		3023+	DS	OFD
000031A4	0057			3024+	USING	*, R5
000031A6	00			3025+T87	DC	A(X87)
000031A7	03			3026+	DC	H'87'
000031A8	01			3027+	DC	X' 00'
000031A9	01			3028+	DC	HL1' 3'
000031AC	000031F0			3029+	DC	HL1' 1'
000031B0	E5E2C3C8 D7404040			3030+V3_87	DC	HL1' 1'
000031B8	00000010			3031+V2_87	DC	A(RE87+16)
000031BC	000031E0			3032+	DC	CL8' VSCHP'
000031C0				3033+	DC	A(16)
000031C0	E710 8F2C 0006	0000112C		3034+	DC	A(RE87)
000031C6	E320 500C 0014	000031AC		3035+*		
000031CC	E722 0000 0006	00000000		3036+X87	DS	OF
000031D2	E730 5009 7000	000031A9		3037+	VL	V1, V1FUDGE
000031D8	E612 3010 3074			3038+	LGF	R2, V2_87
000031DE	07FB			3039+	VL	V2, 0(R2)
000031E0				3040+	VLEB	V3, V3_87, 7
000031E0	41A00000 00000000			3041+	VSCHP	V1, V2, V3, 3, 1
000031E8	00000000 00000000			3042+	BR	R11
000031F0	00000000 00000000			3043+RE87	DS	OF
000031F8	00000000 0000001C			3044+	DROP	R5
000031F8				3045	DC	XL16' 41A000000000000000000000000000000'
000031F8				3046	DC	XL16' 00000000000000000000000000000001C'
00003200				3047 * -1		
00003200	00003220	00003200		3048	VRR_B	VSCHP, 3, 1, 1
00003200	0058			3049+	DS	OFD
00003204	0058			3050+	USING	*, R5
00003206	00			3051+T88	DC	A(X88)
00003207	03			3052+	DC	H'88'
00003208	01			3053+	DC	X' 00'
00003209	01			3054+	DC	HL1' 3'
0000320C	00003250			3055+	DC	HL1' 1'
00003210	E5E2C3C8 D7404040			3056+V3_88	DC	HL1' 1'
00003218	00000010			3057+V2_88	DC	A(RE88+16)
0000321C	00003240			3058+	DC	CL8' VSCHP'
00003220				3059+	DC	A(16)
00003220	E710 8F2C 0006	0000112C		3060+	DC	A(RE88)
00003226	E320 500C 0014	0000320C		3061+*		
0000322C	E722 0000 0006	00000000		3062+X88	DS	OF
00003232	E730 5009 7000	00003209		3063+	VL	V1, V1FUDGE
00003238	E612 3010 3074			3064+	LGF	R2, V2_88
0000323E	07FB			3065+	VL	V2, 0(R2)
00003240				3066+	VLEB	V3, V3_88, 7
00003240	C1A00000 00000000			3067+	VSCHP	V1, V2, V3, 3, 1
00003240	00000000 00000000			3068+	BR	R11
00003248				3069+RE88	DS	OF
00003248				3070+	DROP	R5
00003248				3071	DC	XL16' C1A000000000000000000000000000000'

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
000033C0				3177+RE92	DS	OF	expected 16 byte result
000033C0				3178+	DROP	R5	
000033C0	52640000 00000000			3179	DC	XL16' 52640000000000000000000000000000'	
000033C8	00000000 00000000			3180	DC	XL16' 000000000018446744073709551615C'	
000033D0	00000000 00018446			3181			
000033D8	74407370 9551615C			3182 * 9009000000018446744073709551615			
000033E0				3183	VRR_B	VSCHP, 3, 1, 3	
000033E0		000033E0		3184+	DS	OFD	
000033E0	00003400			3185+	USING	* , R5	base for test data and test routine
000033E4	005D			3186+T93	DC	A(X93)	address of test routine
000033E6	00			3187+	DC	H' 93'	test number
000033E7	03			3188+	DC	X' 00'	
000033E8	01			3189+	DC	HL1' 3'	m4
000033E9	03			3190+	DC	HL1' 1'	m5
000033EC	00003430			3191+V3_93	DC	HL1' 3'	scale
000033F0	E5E2C3C8 D7404040			3192+V2_93	DC	A(RE93+16)	address of v2: 16-byte packed decimal
000033F8	00000010			3193+	DC	CL8' VSCHP'	instruction name
000033FC	00003420			3194+	DC	A(16)	result length
00003400				3195+	DC	A(RE93)	address of expected result
00003400	3196+*			3197+X93	DS	OF	
00003400	E710 8F2C 0006	0000112C		3198+	VL	V1, V1FUDGE	fudge V1
00003406	E320 500C 0014	000033EC		3199+	LGF	R2, V2_93	get v2
0000340C	E722 0000 0006	00000000		3200+	VL	V2, 0(R2)	
00003412	E730 5009 7000	000033E9		3201+	VLEB	V3, V3_93, 7	get v3 scale
00003418	E612 3010 3074			3202+	VSCHP	V1, V2, V3, 3, 1	test instruction
0000341E	07FB			3203+	BR	R11	return
00003420				3204+RE93	DS	OF	expected 16 byte result
00003420				3205+	DROP	R5	
00003420	5D1BC2D9 OFA81678			3206	DC	XL16' 5D1BC2D90FA816780000000000000000'	
00003428	00000000 00000000			3207	DC	XL16' 9009000000018446744073709551615C'	
00003430	90090000 00018446			3208			
00003438	74407370 9551615C			3209 * 999999990018446744073709551615			
00003440				3210	VRR_B	VSCHP, 3, 1, 3	
00003440		00003440		3211+	DS	OFD	
00003440	00003460			3212+	USING	* , R5	base for test data and test routine
00003444	005E			3213+T94	DC	A(X94)	address of test routine
00003446	00			3214+	DC	H' 94'	test number
00003447	03			3215+	DC	X' 00'	
00003448	01			3216+	DC	HL1' 3'	m4
00003449	03			3217+	DC	HL1' 1'	m5
0000344C	00003490			3218+V3_94	DC	HL1' 3'	scale
00003450	E5E2C3C8 D7404040			3219+V2_94	DC	A(RE94+16)	address of v2: 16-byte packed decimal
00003458	00000010			3220+	DC	CL8' VSCHP'	instruction name
0000345C	00003480			3221+	DC	A(16)	result length
00003460				3222+	DC	A(RE94)	address of expected result
00003460	E710 8F2C 0006	0000112C		3223+*			
00003466	E320 500C 0014	0000344C		3224+X94	DS	OF	
0000346C	E722 0000 0006	00000000		3225+	VL	V1, V1FUDGE	fudge V1
00003472	E730 5009 7000	00003449		3226+	LGF	R2, V2_94	get v2
00003472				3227+	VL	V2, 0(R2)	
00003472				3228+	VLEB	V3, V3_94, 7	get v3 scale

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
00003478	E612 3010 3074			3229+ VSCHP V1, V2, V3, 3, 1	test instruction	
0000347E	07FB			3230+ BR R11	return	
00003480				3231+RE94 DS OF	expected 16 byte result	
00003480				3232+ DROP R5		
00003480	5D1ED09B EA546132			3233 DC XL16' 5D1ED09BEA5461320000000000000000'		
00003488	00000000 00000000			3234 DC XL16' 999999990018446744073709551615C'		
00003490	99999999 90018446			3235 *-----		
00003498	74407370 9551615C			3236 * extended float		
				3237 *-----		
				3238 * +0		
000034A0				3239 VRR_B VSCHP, 4, 1, 1		
000034A0		000034A0		3240+ DS OFD		
000034A0	000034C0			3241+ USING *, R5	base for test data and test routine	
000034A4	005F			3242+T95 DC A(X95)	address of test routine	
000034A6	00			3243+ DC H'95'	test number	
000034A7	04			3244+ DC X'00'		
000034A8	01			3245+ DC HL1'4'	m4	
000034A9	01			3246+ DC HL1'1'	m5	
000034AC	000034F0			3247+V3_95 DC HL1'1'	scale	
000034B0	E5E2C3C8 D7404040			3248+V2_95 DC A(RE95+16)	address of v2: 16-byte packed decimal	
000034B8	00000010			3249+ DC CL8' VSCHP'	instruction name	
000034BC	000034E0			3250+ DC A(16)	result length	
				3251+ DC A(RE95)	address of expected result	
000034C0				3252+* 3253+X95 DS OF		
000034C0	E710 8F2C 0006	0000112C		3254+ VL V1, V1FUDGE	fudge V1	
000034C6	E320 500C 0014	000034AC		3255+ LGF R2, V2_95	get v2	
000034CC	E722 0000 0006	00000000		3256+ VL V2, 0(R2)		
000034D2	E730 5009 7000	000034A9		3257+ VLEB V3, V3_95, 7	get v3 scale	
000034D8	E612 3010 4074			3258+ VSCHP V1, V2, V3, 4, 1	test instruction	
000034DE	07FB			3259+ BR R11	return	
000034E0				3260+RE95 DS OF	expected 16 byte result	
000034E0				3261+ DROP R5		
000034E0	00000000 00000000			3262 DC XL16' 00000000000000000000000000000000'		
000034E8	00000000 00000000			3263 DC XL16' 00000000000000000000000000000000C'		
000034F8	00000000 0000000C			3264 * - 0		
00003500				3265 VRR_B VSCHP, 4, 1, 1		
00003500		00003500		3266+ DS OFD		
00003500	00003520			3267+ USING *, R5	base for test data and test routine	
00003504	0060			3268+T96 DC A(X96)	address of test routine	
00003506	00			3269+ DC H'96'	test number	
00003507	04			3270+ DC X'00'		
00003508	01			3271+ DC HL1'4'	m4	
00003509	01			3272+ DC HL1'1'	m5	
0000350C	00003550			3273+V3_96 DC HL1'1'	scale	
00003510	E5E2C3C8 D7404040			3274+V2_96 DC A(RE96+16)	address of v2: 16-byte packed decimal	
00003518	00000010			3275+ DC CL8' VSCHP'	instruction name	
0000351C	00003540			3276+ DC A(16)	result length	
00003520				3277+ DC A(RE96)	address of expected result	
00003520	E710 8F2C 0006	0000112C	3278+*	3279+X96 DS OF		
00003520			3280+	VL V1, V1FUDGE	fudge V1	

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
000035E6	E320 500C 0014		000035CC	3333+	LGF	R2, V2_98	get v2
000035EC	E722 0000 0006		00000000	3334+	VL	V2, 0(R2)	
000035F2	E730 5009 7000		000035C9	3335+	VLEB	V3, V3_98, 7	get v3 scale
000035F8	E612 3010 4074			3336+	VSCHP	V1, V2, V3, 4, 1	test instruction
000035FE	07FB			3337+	BR	R11	return
00003600				3338+RE98	DS	OF	expected 16 byte result
00003600				3339+	DROP	R5	
00003600	C1A00000 00000000			3340	DC	XL16' C1A0000000000000B300000000000000'	
00003608	B3000000 00000000			3341	DC	XL16' 00000000000000000000000000000001D'	
00003610	00000000 00000000						
00003618	00000000 0000001D						
				3342			
				3343 * +9000000000000001			
				3344 VRR_B VSCHP, 4, 1, 2			
00003620				3345+	DS	OFD	
00003620		00003620		3346+	USING	*, R5	base for test data and test routine
00003620	00003640			3347+T99	DC	A(X99)	address of test routine
00003624	0063			3348+	DC	H'99'	test number
00003626	00			3349+	DC	X'00'	
00003627	04			3350+	DC	HL1'4'	m4
00003628	01			3351+	DC	HL1'1'	m5
00003629	02			3352+V3_99	DC	HL1'2'	scale
0000362C	00003670			3353+V2_99	DC	A(RE99+16)	address of v2: 16-byte packed decimal
00003630	E5E2C3C8 D7404040			3354+	DC	CL8' VSCHP'	instruction name
00003638	00000010			3355+	DC	A(16)	result length
0000363C	00003660			3356+	DC	A(RE99)	address of expected result
00003640				3357+*			
00003640	E710 8F2C 0006		0000112C	3359+	DS	OF	
00003646	E320 500C 0014		0000362C	3360+	LGF	R2, V2_99	fudge V1
0000364C	E722 0000 0006		00000000	3361+	VL	V2, 0(R2)	get v2
00003652	E730 5009 7000		00003629	3362+	VLEB	V3, V3_99, 7	get v3 scale
00003658	E612 3010 4074			3363+	VSCHP	V1, V2, V3, 4, 1	test instruction
0000365E	07FB			3364+	BR	R11	return
00003660				3365+RE99	DS	OF	expected 16 byte result
00003660				3366+	DROP	R5	
00003660	4FC7D713 B49DA006			3367	DC	XL16' 4FC7D713B49DA0064140000000000000'	
00003668	41400000 00000000			3368	DC	XL16' 00000000000000009000000000000001C'	
00003670	00000000 00000009						
00003678	00000000 0000001C						
				3369			
				3370 * -9223372036854775808			
				3371 VRR_B VSCHP, 4, 1, 2			
00003680				3372+	DS	OFD	
00003680		00003680		3373+	USING	*, R5	base for test data and test routine
00003680	000036A0			3374+T100	DC	A(X100)	address of test routine
00003684	0064			3375+	DC	H'100'	test number
00003686	00			3376+	DC	X'00'	
00003687	04			3377+	DC	HL1'4'	m4
00003688	01			3378+	DC	HL1'1'	m5
00003689	02			3379+V3_100	DC	HL1'2'	scale
0000368C	000036D0			3380+V2_100	DC	A(RE100+16)	address of v2: 16-byte packed decimal
00003690	E5E2C3C8 D7404040			3381+	DC	CL8' VSCHP'	instruction name
00003698	00000010			3382+	DC	A(16)	result length
0000369C	000036C0			3383+	DC	A(RE100)	address of expected result
				3384+*			

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
000036A0				3385+X100	DS	OF	
000036A0	E710 8F2C 0006	0000112C	3386+	VL	V1, V1FUDGE	fudge V1	
000036A6	E320 500C 0014	0000368C	3387+	LGF	R2, V2_100	get v2	
000036AC	E722 0000 0006	00000000	3388+	VL	V2, 0(R2)		
000036B2	E730 5009 7000	00003689	3389+	VLEB	V3, V3_100, 7	get v3 scale	
000036B8	E612 3010 4074		3390+	VSCHP	V1, V2, V3, 4, 1	test instruction	
000036BE	07FB		3391+	BR	R11	return	
000036C0			3392+RE100	DS	OF	expected 16 byte result	
000036C0			3393+	DROP	R5		
000036C0	D2320000 00000000		3394	DC	XL16' D232000000000000C400000000000000'		
000036C8	C4000000 00000000						
000036D0	00000000 00009223		3395	DC	XL16' 0000000000009223372036854775808D'		
000036D8	37203685 4775808D		3396				
			3397 * 9223372036854775807				
000036E0		000036E0	3400+	USING	*, R5	base for test data and test routine	
000036E0	00003700		3401+T101	DC	A(X101)	address of test routine	
000036E4	0065		3402+	DC	H' 101'	test number	
000036E6	00		3403+	DC	X' 00'		
000036E7	04		3404+	DC	HL1' 4'	m4	
000036E8	01		3405+	DC	HL1' 1'	m5	
000036E9	02		3406+V3_101	DC	HL1' 2'	scale	
000036EC	00003730		3407+V2_101	DC	A(RE101+16)	address of v2: 16-byte packed decimal	
000036F0	E5E2C3C8 D7404040		3408+	DC	CL8' VSCHP'	instruction name	
000036F8	00000010		3409+	DC	A(16)	result length	
000036FC	00003720		3410+	DC	A(RE101)	address of expected result	
3411+*							
00003700			3412+X101	DS	OF		
00003700	E710 8F2C 0006	0000112C	3413+	VL	V1, V1FUDGE	fudge V1	
00003706	E320 500C 0014	000036EC	3414+	LGF	R2, V2_101	get v2	
0000370C	E722 0000 0006	00000000	3415+	VL	V2, 0(R2)		
00003712	E730 5009 7000	000036E9	3416+	VLEB	V3, V3_101, 7	get v3 scale	
00003718	E612 3010 4074		3417+	VSCHP	V1, V2, V3, 4, 1	test instruction	
0000371E	07FB		3418+	BR	R11	return	
00003720			3419+RE101	DS	OF	expected 16 byte result	
00003720			3420+	DROP	R5		
00003720	5231FFFF FFFFFFFF		3421	DC	XL16' 5231FFFFFFFF44FF9C0000000000'		
00003728	44FF9C00 00000000						
00003730	00000000 00009223		3422	DC	XL16' 0000000000009223372036854775807C'		
00003738	37203685 4775807C		3423				
			3424 * 18446744073709551615				
00003740		00003740	3425	VRR_B	VSCHP, 4, 1, 2		
00003740			3426+	DS	OFD	base for test data and test routine	
00003740	00003760		3427+	USING	*, R5	address of test routine	
00003744	0066		3428+T102	DC	A(X102)	test number	
00003746	00		3429+	DC	H' 102'		
00003747	04		3430+	DC	X' 00'		
00003748	01		3431+	DC	HL1' 4'	m4	
00003749	02		3432+	DC	HL1' 1'	m5	
0000374C	00003790		3433+V3_102	DC	HL1' 2'	scale	
00003750	E5E2C3C8 D7404040		3434+V2_102	DC	A(RE102+16)	address of v2: 16-byte packed decimal	
00003758	00000010		3435+	DC	CL8' VSCHP'	instruction name	
			3436+	DC	A(16)	result length	

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
0000375C	00003780			3437+ 3438+*	DC	A(RE102)	address of expected result
00003760	E710 8F2C 0006		0000112C	3439+X102	DS	OF	
00003760	E320 500C 0014		0000374C	3440+	VL	V1, V1FUDGE	fudge V1
00003766	E722 0000 0006		00000000	3441+	LGF	R2, V2_102	get v2
0000376C	E730 5009 7000		00003749	3442+	VL	V2, 0(R2)	
00003772	E612 3010 4074			3443+	VLEB	V3, V3_102, 7	get v3 scale
00003778	07FB			3444+	VSCHP	V1, V2, V3, 4, 1	test instruction
0000377E				3445+	BR	R11	return
00003780				3446+RE102	DS	OF	expected 16 byte result
00003780				3447+	DROP	R5	
00003780	5263FFFF FFFFFFFF			3448	DC	XL16' 5263FFFFFFFFFFFF44FF9C00000000000'	
00003788	44FF9C00 00000000			3449	DC	XL16' 0000000000018446744073709551615C'	
00003798	74407370 9551615C			3450 3451 * 9009000000018446744073709551615			
000037A0	000037A0			3452 VRR_B VSCHP, 4, 1, 3			
000037A0	000037C0			3453+ DS OFD			base for test data and test routine
000037A4	0067			3454+ USING *, R5			address of test routine
000037A6	00			3455+T103 DC A(X103)			test number
000037A7	04			3456+ DC H' 103'			
000037A8	01			3457+ DC X' 00'			
000037A9	03			3458+ DC HL1' 4'			m4
000037AC	000037F0			3459+ DC HL1' 1'			m5
000037B0	E5E2C3C8 D7404040			3460+V3_103 DC HL1' 3'			scale
000037B8	00000010			3461+V2_103 DC A(RE103+16)			address of v2: 16-byte packed decimal
000037BC	000037E0			3462+ DC CL8' VSCHP'			instruction name
000037C0				3463+ DC A(16)			result length
000037C0	000037E0			3464+ DC A(RE103)			address of expected result
000037C0	3465+*						
000037C0	E710 8F2C 0006		0000112C	3466+X103 DS OF			
000037C6	E320 500C 0014		000037AC	3467+ VL V1, V1FUDGE			fudge V1
000037CC	E722 0000 0006		00000000	3468+ LGF R2, V2_103			get v2
000037D2	E730 5009 7000		000037A9	3469+ VL V2, 0(R2)			
000037D8	E612 3010 4074			3470+ VLEB V3, V3_103, 7			get v3 scale
000037DE	07FB			3471+ VSCHP V1, V2, V3, 4, 1			test instruction
000037E0				3472+ BR R11			return
000037E0				3473+RE103 DS OF			expected 16 byte result
000037E0				3474+ DROP R5			
000037E0	5D1BC2D9 OFA81677			3475 DC XL16' 5D1BC2D90FA816774F8E890963FFFC2'			
000037E8	4F8E8909 63FFFC2			3476 DC XL16' 9009000000018446744073709551615C'			
000037F0	90090000 00018446			3477 3478 * 9999999990018446744073709551615			
000037F8	74407370 9551615C			3479 VRR_B VSCHP, 4, 1, 3			
00003800	00003800			3480+ DS OFD			base for test data and test routine
00003800	00003820			3481+ USING *, R5			address of test routine
00003804	0068			3482+T104 DC A(X104)			test number
00003806	00			3483+ DC H' 104'			
00003807	04			3484+ DC X' 00'			
00003808	01			3485+ DC HL1' 4'			m4
00003809	03			3486+ DC HL1' 1'			m5
0000380C	00003850			3487+V3_104 DC HL1' 3'			scale
				3488+V2_104 DC A(RE104+16)			address of v2: 16-byte packed decimal

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00003810	E5E2C3C8 D7404040			3489+	DC	CL8' VSCHP'	instruction name
00003818	00000010			3490+	DC	A(16)	result length
0000381C	00003840			3491+	DC	A(RE104)	address of expected result
3492+*				3493+X104	DS	OF	
00003820					VL	V1, V1FUDGE	fudge V1
00003820	E710 8F2C 0006	0000112C	3494+		LGF	R2, V2_104	get v2
00003826	E320 500C 0014	0000380C	3495+		VL	V2, 0(R2)	
0000382C	E722 0000 0006	00000000	3496+		VLEB	V3, V3_104, 7	get v3 scale
00003832	E730 5009 7000	00003809	3497+		VSCHP	V1, V2, V3, 4, 1	test instruction
00003838	E612 3010 4074		3498+		BR	R11	return
0000383E	07FB		3499+		3500+RE104	OF	expected 16 byte result
00003840			3501+		DROP	R5	
00003840	5D1ED09B EA546132		3502		DC	XL16' 5D1ED09BEA5461324F1798D1BB5FFC2'	
00003848	4F1798D1 BB5FFFC2						
00003850	99999999 90018446		3503		DC	XL16' 999999990018446744073709551615C'	
00003858	74407370 9551615C						
			3504				
			3505				
00003860	00000000		3506		DC	F' 0'	END OF TABLE
00003864	00000000		3507		DC	F' 0'	
			3508 *				
			3509 *	table of pointers to individual tests			
			3510 *				
00003868			3511 E6TESTS	DS	OF		
			3512	PTTABLE			
00003868			3513+TTABLE	DS	OF		
00003868	00001160		3514+	DC	A(T1)		TEST &CUR
0000386C	000011C0		3515+	DC	A(T2)		TEST &CUR
00003870	00001220		3516+	DC	A(T3)		TEST &CUR
00003874	00001280		3517+	DC	A(T4)		TEST &CUR
00003878	000012E0		3518+	DC	A(T5)		TEST &CUR
0000387C	00001340		3519+	DC	A(T6)		TEST &CUR
00003880	000013A0		3520+	DC	A(T7)		TEST &CUR
00003884	00001400		3521+	DC	A(T8)		TEST &CUR
00003888	00001460		3522+	DC	A(T9)		TEST &CUR
0000388C	000014C0		3523+	DC	A(T10)		TEST &CUR
00003890	00001520		3524+	DC	A(T11)		TEST &CUR
00003894	00001580		3525+	DC	A(T12)		TEST &CUR
00003898	000015E0		3526+	DC	A(T13)		TEST &CUR
0000389C	00001640		3527+	DC	A(T14)		TEST &CUR
000038A0	000016A0		3528+	DC	A(T15)		TEST &CUR
000038A4	00001700		3529+	DC	A(T16)		TEST &CUR
000038A8	00001760		3530+	DC	A(T17)		TEST &CUR
000038AC	000017C0		3531+	DC	A(T18)		TEST &CUR
000038B0	00001820		3532+	DC	A(T19)		TEST &CUR
000038B4	00001880		3533+	DC	A(T20)		TEST &CUR
000038B8	000018E0		3534+	DC	A(T21)		TEST &CUR
000038BC	00001940		3535+	DC	A(T22)		TEST &CUR
000038C0	000019A0		3536+	DC	A(T23)		TEST &CUR
000038C4	00001A00		3537+	DC	A(T24)		TEST &CUR
000038C8	00001A60		3538+	DC	A(T25)		TEST &CUR
000038CC	00001AC0		3539+	DC	A(T26)		TEST &CUR
000038D0	00001B20		3540+	DC	A(T27)		TEST &CUR
000038D4	00001B80		3541+	DC	A(T28)		TEST &CUR
000038D8	00001BE0		3542+	DC	A(T29)		TEST &CUR

LOC	OBJECT CODE	ADDR1	ADDR2	STMT	
000038DC	00001C40		3543+	DC A(T30)	TEST &CUR
000038E0	00001CA0		3544+	DC A(T31)	TEST &CUR
000038E4	00001D00		3545+	DC A(T32)	TEST &CUR
000038E8	00001D60		3546+	DC A(T33)	TEST &CUR
000038EC	00001DC0		3547+	DC A(T34)	TEST &CUR
000038F0	00001E20		3548+	DC A(T35)	TEST &CUR
000038F4	00001E80		3549+	DC A(T36)	TEST &CUR
000038F8	00001EE0		3550+	DC A(T37)	TEST &CUR
000038FC	00001F40		3551+	DC A(T38)	TEST &CUR
00003900	00001FA0		3552+	DC A(T39)	TEST &CUR
00003904	00002000		3553+	DC A(T40)	TEST &CUR
00003908	00002060		3554+	DC A(T41)	TEST &CUR
0000390C	000020C0		3555+	DC A(T42)	TEST &CUR
00003910	00002120		3556+	DC A(T43)	TEST &CUR
00003914	00002180		3557+	DC A(T44)	TEST &CUR
00003918	000021E0		3558+	DC A(T45)	TEST &CUR
0000391C	00002240		3559+	DC A(T46)	TEST &CUR
00003920	000022A0		3560+	DC A(T47)	TEST &CUR
00003924	00002300		3561+	DC A(T48)	TEST &CUR
00003928	00002360		3562+	DC A(T49)	TEST &CUR
0000392C	000023C0		3563+	DC A(T50)	TEST &CUR
00003930	00002420		3564+	DC A(T51)	TEST &CUR
00003934	00002480		3565+	DC A(T52)	TEST &CUR
00003938	000024E0		3566+	DC A(T53)	TEST &CUR
0000393C	00002540		3567+	DC A(T54)	TEST &CUR
00003940	000025A0		3568+	DC A(T55)	TEST &CUR
00003944	00002600		3569+	DC A(T56)	TEST &CUR
00003948	00002660		3570+	DC A(T57)	TEST &CUR
0000394C	000026C0		3571+	DC A(T58)	TEST &CUR
00003950	00002720		3572+	DC A(T59)	TEST &CUR
00003954	00002780		3573+	DC A(T60)	TEST &CUR
00003958	000027E0		3574+	DC A(T61)	TEST &CUR
0000395C	00002840		3575+	DC A(T62)	TEST &CUR
00003960	000028A0		3576+	DC A(T63)	TEST &CUR
00003964	00002900		3577+	DC A(T64)	TEST &CUR
00003968	00002960		3578+	DC A(T65)	TEST &CUR
0000396C	000029C0		3579+	DC A(T66)	TEST &CUR
00003970	00002A20		3580+	DC A(T67)	TEST &CUR
00003974	00002A80		3581+	DC A(T68)	TEST &CUR
00003978	00002AE0		3582+	DC A(T69)	TEST &CUR
0000397C	00002B40		3583+	DC A(T70)	TEST &CUR
00003980	00002BA0		3584+	DC A(T71)	TEST &CUR
00003984	00002C00		3585+	DC A(T72)	TEST &CUR
00003988	00002C60		3586+	DC A(T73)	TEST &CUR
0000398C	00002CC0		3587+	DC A(T74)	TEST &CUR
00003990	00002D20		3588+	DC A(T75)	TEST &CUR
00003994	00002D80		3589+	DC A(T76)	TEST &CUR
00003998	00002DE0		3590+	DC A(T77)	TEST &CUR
0000399C	00002E40		3591+	DC A(T78)	TEST &CUR
000039A0	00002EA0		3592+	DC A(T79)	TEST &CUR
000039A4	00002F00		3593+	DC A(T80)	TEST &CUR
000039A8	00002F60		3594+	DC A(T81)	TEST &CUR
000039AC	00002FC0		3595+	DC A(T82)	TEST &CUR
000039B0	00003020		3596+	DC A(T83)	TEST &CUR
000039B4	00003080		3597+	DC A(T84)	TEST &CUR
000039B8	000030E0		3598+	DC A(T85)	TEST &CUR

LOC	OBJECT CODE	ADDR1	ADDR2	STMT	
000039BC	00003140		3599+	DC A(T86)	TEST &CUR
000039C0	000031A0		3600+	DC A(T87)	TEST &CUR
000039C4	00003200		3601+	DC A(T88)	TEST &CUR
000039C8	00003260		3602+	DC A(T89)	TEST &CUR
000039CC	000032C0		3603+	DC A(T90)	TEST &CUR
000039D0	00003320		3604+	DC A(T91)	TEST &CUR
000039D4	00003380		3605+	DC A(T92)	TEST &CUR
000039D8	000033E0		3606+	DC A(T93)	TEST &CUR
000039DC	00003440		3607+	DC A(T94)	TEST &CUR
000039E0	000034A0		3608+	DC A(T95)	TEST &CUR
000039E4	00003500		3609+	DC A(T96)	TEST &CUR
000039E8	00003560		3610+	DC A(T97)	TEST &CUR
000039EC	000035C0		3611+	DC A(T98)	TEST &CUR
000039F0	00003620		3612+	DC A(T99)	TEST &CUR
000039F4	00003680		3613+	DC A(T100)	TEST &CUR
000039F8	000036E0		3614+	DC A(T101)	TEST &CUR
000039FC	00003740		3615+	DC A(T102)	TEST &CUR
00003A00	000037A0		3616+	DC A(T103)	TEST &CUR
00003A04	00003800		3617+	DC A(T104)	TEST &CUR
			3618+*		
00003A08	00000000		3619+	DC A(0)	END OF TABLE
00003A0C	00000000		3620+	DC A(0)	
			3621		
00003A10	00000000		3622	DC F' 0'	END OF TABLE
00003A14	00000000		3623	DC F' 0'	

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
				3625 *****	*****	*****
				3626 *	Register equates	
				3627 *****	*****	*****
	00000000	00000001	3629	R0	EQU	0
	00000001	00000001	3630	R1	EQU	1
	00000002	00000001	3631	R2	EQU	2
	00000003	00000001	3632	R3	EQU	3
	00000004	00000001	3633	R4	EQU	4
	00000005	00000001	3634	R5	EQU	5
	00000006	00000001	3635	R6	EQU	6
	00000007	00000001	3636	R7	EQU	7
	00000008	00000001	3637	R8	EQU	8
	00000009	00000001	3638	R9	EQU	9
	0000000A	00000001	3639	R10	EQU	10
	0000000B	00000001	3640	R11	EQU	11
	0000000C	00000001	3641	R12	EQU	12
	0000000D	00000001	3642	R13	EQU	13
	0000000E	00000001	3643	R14	EQU	14
	0000000F	00000001	3644	R15	EQU	15
				3646 *****	*****	*****
				3647 *	Register equates	
				3648 *****	*****	*****
	00000000	00000001	3650	FPR0	EQU	0
	00000001	00000001	3651	FPR1	EQU	1
	00000002	00000001	3652	FPR2	EQU	2
	00000003	00000001	3653	FPR3	EQU	3
	00000004	00000001	3654	FPR4	EQU	4
	00000005	00000001	3655	FPR5	EQU	5
	00000006	00000001	3656	FPR6	EQU	6
	00000007	00000001	3657	FPR7	EQU	7
	00000008	00000001	3658	FPR8	EQU	8
	00000009	00000001	3659	FPR9	EQU	9
	0000000A	00000001	3660	FPR10	EQU	10
	0000000B	00000001	3661	FPR11	EQU	11
	0000000C	00000001	3662	FPR12	EQU	12
	0000000D	00000001	3663	FPR13	EQU	13
	0000000E	00000001	3664	FPR14	EQU	14
	0000000F	00000001	3665	FPR15	EQU	15
				3667 *****	*****	*****
				3668 *	Register equates	
				3669 *****	*****	*****
	00000000	00000001	3671	V0	EQU	0
	00000001	00000001	3672	V1	EQU	1
	00000002	00000001	3673	V2	EQU	2
	00000003	00000001	3674	V3	EQU	3
	00000004	00000001	3675	V4	EQU	4

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
		00000005	00000001	3676 V5	EQU	5
		00000006	00000001	3677 V6	EQU	6
		00000007	00000001	3678 V7	EQU	7
		00000008	00000001	3679 V8	EQU	8
		00000009	00000001	3680 V9	EQU	9
		0000000A	00000001	3681 V10	EQU	10
		0000000B	00000001	3682 V11	EQU	11
		0000000C	00000001	3683 V12	EQU	12
		0000000D	00000001	3684 V13	EQU	13
		0000000E	00000001	3685 V14	EQU	14
		0000000F	00000001	3686 V15	EQU	15
		00000010	00000001	3687 V16	EQU	16
		00000011	00000001	3688 V17	EQU	17
		00000012	00000001	3689 V18	EQU	18
		00000013	00000001	3690 V19	EQU	19
		00000014	00000001	3691 V20	EQU	20
		00000015	00000001	3692 V21	EQU	21
		00000016	00000001	3693 V22	EQU	22
		00000017	00000001	3694 V23	EQU	23
		00000018	00000001	3695 V24	EQU	24
		00000019	00000001	3696 V25	EQU	25
		0000001A	00000001	3697 V26	EQU	26
		0000001B	00000001	3698 V27	EQU	27
		0000001C	00000001	3699 V28	EQU	28
		0000001D	00000001	3700 V29	EQU	29
		0000001E	00000001	3701 V30	EQU	30
		0000001F	00000001	3702 V31	EQU	31
				3703		
				3704	END	

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES
R6	U	00000006	1	3635	3447 3454 3474 3481 3501
R7	U	00000007	1	3636	
R8	U	00000008	1	3637	157 161 162 163 165
R9	U	00000009	1	3638	158 165 166 168
RE1	F	000011A0	4	714	702 705
RE10	F	00001500	4	956	944 947
RE100	F	000036C0	4	3392	3380 3383
RE101	F	00003720	4	3419	3407 3410
RE102	F	00003780	4	3446	3434 3437
RE103	F	000037E0	4	3473	3461 3464
RE104	F	00003840	4	3500	3488 3491
RE11	F	00001560	4	982	970 973
RE12	F	000015C0	4	1008	996 999
RE13	F	00001620	4	1035	1023 1026
RE14	F	00001680	4	1062	1050 1053
RE15	F	000016E0	4	1089	1077 1080
RE16	F	00001740	4	1116	1104 1107
RE17	F	000017A0	4	1146	1134 1137
RE18	F	00001800	4	1172	1160 1163
RE19	F	00001860	4	1198	1186 1189
RE2	F	00001200	4	740	728 731
RE20	F	000018C0	4	1224	1212 1215
RE21	F	00001920	4	1251	1239 1242
RE22	F	00001980	4	1278	1266 1269
RE23	F	000019E0	4	1305	1293 1296
RE24	F	00001A40	4	1332	1320 1323
RE25	F	00001AA0	4	1365	1353 1356
RE26	F	00001B00	4	1391	1379 1382
RE27	F	00001B60	4	1417	1405 1408
RE28	F	00001BC0	4	1443	1431 1434
RE29	F	00001C20	4	1470	1458 1461
RE3	F	00001260	4	766	754 757
RE30	F	00001C80	4	1497	1485 1488
RE31	F	00001CE0	4	1524	1512 1515
RE32	F	00001D40	4	1551	1539 1542
RE33	F	00001DA0	4	1581	1569 1572
RE34	F	00001E00	4	1607	1595 1598
RE35	F	00001E60	4	1633	1621 1624
RE36	F	00001EC0	4	1659	1647 1650
RE37	F	00001F20	4	1686	1674 1677
RE38	F	00001F80	4	1713	1701 1704
RE39	F	00001FE0	4	1740	1728 1731
RE4	F	000012C0	4	792	780 783
RE40	F	00002040	4	1767	1755 1758
RE41	F	000020A0	4	1797	1785 1788
RE42	F	00002100	4	1823	1811 1814
RE43	F	00002160	4	1849	1837 1840
RE44	F	000021C0	4	1875	1863 1866
RE45	F	00002220	4	1902	1890 1893
RE46	F	00002280	4	1929	1917 1920
RE47	F	000022E0	4	1956	1944 1947
RE48	F	00002340	4	1983	1971 1974
RE49	F	000023A0	4	2016	2004 2007
RE5	F	00001320	4	819	807 810
RE50	F	00002400	4	2042	2030 2033

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES
RE51	F	00002460	4	2068	2056 2059
RE52	F	000024C0	4	2094	2082 2085
RE53	F	00002520	4	2121	2109 2112
RE54	F	00002580	4	2148	2136 2139
RE55	F	000025E0	4	2175	2163 2166
RE56	F	00002640	4	2202	2190 2193
RE57	F	000026A0	4	2232	2220 2223
RE58	F	00002700	4	2258	2246 2249
RE59	F	00002760	4	2284	2272 2275
RE6	F	00001380	4	846	834 837
RE60	F	000027C0	4	2310	2298 2301
RE61	F	00002820	4	2337	2325 2328
RE62	F	00002880	4	2364	2352 2355
RE63	F	000028E0	4	2391	2379 2382
RE64	F	00002940	4	2418	2406 2409
RE65	F	000029A0	4	2445	2433 2436
RE66	F	00002A00	4	2472	2460 2463
RE67	F	00002A60	4	2501	2489 2492
RE68	F	00002AC0	4	2527	2515 2518
RE69	F	00002B20	4	2553	2541 2544
RE7	F	000013E0	4	873	861 864
RE70	F	00002B80	4	2579	2567 2570
RE71	F	00002BE0	4	2606	2594 2597
RE72	F	00002C40	4	2633	2621 2624
RE73	F	00002CA0	4	2660	2648 2651
RE74	F	00002D00	4	2687	2675 2678
RE75	F	00002D60	4	2714	2702 2705
RE76	F	00002DC0	4	2741	2729 2732
RE77	F	00002E20	4	2775	2763 2766
RE78	F	00002E80	4	2801	2789 2792
RE79	F	00002EE0	4	2827	2815 2818
RE8	F	00001440	4	900	888 891
RE80	F	00002F40	4	2853	2841 2844
RE81	F	00002FA0	4	2880	2868 2871
RE82	F	00003000	4	2907	2895 2898
RE83	F	00003060	4	2934	2922 2925
RE84	F	000030C0	4	2961	2949 2952
RE85	F	00003120	4	2991	2979 2982
RE86	F	00003180	4	3017	3005 3008
RE87	F	000031E0	4	3043	3031 3034
RE88	F	00003240	4	3069	3057 3060
RE89	F	000032A0	4	3096	3084 3087
RE9	F	000014A0	4	930	918 921
RE90	F	00003300	4	3123	3111 3114
RE91	F	00003360	4	3150	3138 3141
RE92	F	000033C0	4	3177	3165 3168
RE93	F	00003420	4	3204	3192 3195
RE94	F	00003480	4	3231	3219 3222
RE95	F	000034E0	4	3260	3248 3251
RE96	F	00003540	4	3286	3274 3277
RE97	F	000035A0	4	3312	3300 3303
RE98	F	00003600	4	3338	3326 3329
RE99	F	00003660	4	3365	3353 3356
READDR	A	0000001C	4	594	233
REG2LOW	U	000000DD	1	508	
REG2PATT	U	AABBCCDD	1	507	

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES
RELEN	A	00000018	4	593	
RPTDWSAV	D	00000550	8	428	417 419
RPTERROR	I	00000524	4	412	336 384
RPTSAVE	F	00000544	4	425	412 422
RPTSVR5	F	00000548	4	426	413 421
SCALE	U	00000009	1	590	327 376
SKL0001	U	0000006B	1	187	203
SKT0001	C	0000022A	26	184	187 204
SVOLDPSW	U	00000140	0	122	
T1	A	00001160	4	696	3514
T10	A	000014C0	4	938	3523
T100	A	00003680	4	3374	3613
T101	A	000036E0	4	3401	3614
T102	A	00003740	4	3428	3615
T103	A	000037A0	4	3455	3616
T104	A	00003800	4	3482	3617
T11	A	00001520	4	964	3524
T12	A	00001580	4	990	3525
T13	A	000015E0	4	1017	3526
T14	A	00001640	4	1044	3527
T15	A	000016A0	4	1071	3528
T16	A	00001700	4	1098	3529
T17	A	00001760	4	1128	3530
T18	A	000017C0	4	1154	3531
T19	A	00001820	4	1180	3532
T2	A	000011C0	4	722	3515
T20	A	00001880	4	1206	3533
T21	A	000018E0	4	1233	3534
T22	A	00001940	4	1260	3535
T23	A	000019A0	4	1287	3536
T24	A	00001A00	4	1314	3537
T25	A	00001A60	4	1347	3538
T26	A	00001AC0	4	1373	3539
T27	A	00001B20	4	1399	3540
T28	A	00001B80	4	1425	3541
T29	A	00001BE0	4	1452	3542
T3	A	00001220	4	748	3516
T30	A	00001C40	4	1479	3543
T31	A	00001CA0	4	1506	3544
T32	A	00001D00	4	1533	3545
T33	A	00001D60	4	1563	3546
T34	A	00001DC0	4	1589	3547
T35	A	00001E20	4	1615	3548
T36	A	00001E80	4	1641	3549
T37	A	00001EE0	4	1668	3550
T38	A	00001F40	4	1695	3551
T39	A	00001FA0	4	1722	3552
T4	A	00001280	4	774	3517
T40	A	00002000	4	1749	3553
T41	A	00002060	4	1779	3554
T42	A	000020C0	4	1805	3555
T43	A	00002120	4	1831	3556
T44	A	00002180	4	1857	3557
T45	A	000021E0	4	1884	3558
T46	A	00002240	4	1911	3559
T47	A	000022A0	4	1938	3560

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES
T48	A	00002300	4	1965	3561
T49	A	00002360	4	1998	3562
T5	A	000012E0	4	801	3518
T50	A	000023C0	4	2024	3563
T51	A	00002420	4	2050	3564
T52	A	00002480	4	2076	3565
T53	A	000024E0	4	2103	3566
T54	A	00002540	4	2130	3567
T55	A	000025A0	4	2157	3568
T56	A	00002600	4	2184	3569
T57	A	00002660	4	2214	3570
T58	A	000026C0	4	2240	3571
T59	A	00002720	4	2266	3572
T6	A	00001340	4	828	3519
T60	A	00002780	4	2292	3573
T61	A	000027E0	4	2319	3574
T62	A	00002840	4	2346	3575
T63	A	000028A0	4	2373	3576
T64	A	00002900	4	2400	3577
T65	A	00002960	4	2427	3578
T66	A	000029C0	4	2454	3579
T67	A	00002A20	4	2483	3580
T68	A	00002A80	4	2509	3581
T69	A	00002AE0	4	2535	3582
T7	A	000013A0	4	855	3520
T70	A	00002B40	4	2561	3583
T71	A	00002BA0	4	2588	3584
T72	A	00002C00	4	2615	3585
T73	A	00002C60	4	2642	3586
T74	A	00002CC0	4	2669	3587
T75	A	00002D20	4	2696	3588
T76	A	00002D80	4	2723	3589
T77	A	00002DE0	4	2757	3590
T78	A	00002E40	4	2783	3591
T79	A	00002EA0	4	2809	3592
T8	A	00001400	4	882	3521
T80	A	00002F00	4	2835	3593
T81	A	00002F60	4	2862	3594
T82	A	00002FC0	4	2889	3595
T83	A	00003020	4	2916	3596
T84	A	00003080	4	2943	3597
T85	A	000030E0	4	2973	3598
T86	A	00003140	4	2999	3599
T87	A	000031A0	4	3025	3600
T88	A	00003200	4	3051	3601
T89	A	00003260	4	3078	3602
T9	A	00001460	4	912	3522
T90	A	000032C0	4	3105	3603
T91	A	00003320	4	3132	3604
T92	A	00003380	4	3159	3605
T93	A	000033E0	4	3186	3606
T94	A	00003440	4	3213	3607
T95	A	000034A0	4	3242	3608
T96	A	00003500	4	3268	3609
T97	A	00003560	4	3294	3610
T98	A	000035C0	4	3320	3611

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES																
T99	A	00003620	4	3347	3612																
TESTING	F	00001004	4	519	224																
TNUM	H	00000004	2	586	223	304															
TSUB	A	00000000	4	585	226	353															
TTABLE	F	00003868	4	3513																	
V0	U	00000000	1	3671																	
V1	U	00000001	1	3672	229	298	708	712	734	738	760	764	786	790	813	817	840				
					844	867	871	894	898	924	928	950	954	976	980	1002	1006				
					1029	1033	1056	1060	1083	1087	1110	1114	1140	1144	1166	1170	1192				
					1196	1218	1222	1245	1249	1272	1276	1299	1303	1326	1330	1359	1363				
					1385	1389	1411	1415	1437	1441	1464	1468	1491	1495	1518	1522	1545				
					1549	1575	1579	1601	1605	1627	1631	1653	1657	1680	1684	1707	1711				
					1734	1738	1761	1765	1791	1795	1817	1821	1843	1847	1869	1873	1896				
					1900	1923	1927	1950	1954	1977	1981	2010	2014	2036	2040	2062	2066				
					2088	2092	2115	2119	2142	2146	2169	2173	2196	2200	2226	2230	2252				
					2256	2278	2282	2304	2308	2331	2335	2358	2362	2385	2389	2412	2416				
					2439	2443	2466	2470	2495	2499	2521	2525	2547	2551	2573	2577	2600				
					2604	2627	2631	2654	2658	2681	2685	2708	2712	2735	2739	2769	2773				
					2795	2799	2821	2825	2847	2851	2874	2878	2901	2905	2928	2932	2955				
					2959	2985	2989	3011	3015	3037	3041	3063	3067	3090	3094	3117	3121				
					3144	3148	3171	3175	3198	3202	3225	3229	3254	3258	3280	3284	3306				
					3310	3332	3336	3359	3363	3386	3390	3413	3417	3440	3444	3467	3471				
					3494	3498															
V10	U	0000000A	1	3681	257	260															
V11	U	0000000B	1	3682	256	257															
V12	U	0000000C	1	3683																	
V13	U	0000000D	1	3684																	
V14	U	0000000E	1	3685																	
V15	U	0000000F	1	3686																	
V16	U	00000010	1	3687																	
V17	U	00000011	1	3688																	
V18	U	00000012	1	3689																	
V19	U	00000013	1	3690																	
V1FUDGE	X	0000112C	16	576	708	734	760	786	813	840	867	894	924	950	976	1002	1029				
					1056	1083	1110	1140	1166	1192	1218	1245	1272	1299	1326	1359	1385				
					1411	1437	1464	1491	1518	1545	1575	1601	1627	1653	1680	1707	1734				
					1761	1791	1817	1843	1869	1896	1923	1950	1977	2010	2036	2062	2088				
					2115	2142	2169	2196	2226	2252	2278	2304	2331	2358	2385	2412	2439				
					2466	2495	2521	2547	2573	2600	2627	2654	2681	2708	2735	2769	2795				
					2821	2847	2874	2901	2928	2955	2985	3011	3037	3063	3090	3117	3144				
					3171	3198	3225	3254	3280	3306	3332	3359	3386	3413	3440	3467	3494				
V1INPUT	X	0000113C	16	577																	
V10OUTPUT	X	0000110C	16	574	229	234															
V2	U	00000002	1	3673	256	710	712	736	738	762	764	788	790	815	817	842	844				
					869	871	896	898	926	928	952	954	978	980	1004	1006	1031				
					1033	1058	1060	1085	1087	1112	1114	1142	1144	1168	1170	1194	1196		</td		

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES
V2_42	A	000020CC	4	1811	1818
V2_43	A	0000212C	4	1837	1844
V2_44	A	0000218C	4	1863	1870
V2_45	A	000021EC	4	1890	1897
V2_46	A	0000224C	4	1917	1924
V2_47	A	000022AC	4	1944	1951
V2_48	A	0000230C	4	1971	1978
V2_49	A	0000236C	4	2004	2011
V2_5	A	000012EC	4	807	814
V2_50	A	000023CC	4	2030	2037
V2_51	A	0000242C	4	2056	2063
V2_52	A	0000248C	4	2082	2089
V2_53	A	000024EC	4	2109	2116
V2_54	A	0000254C	4	2136	2143
V2_55	A	000025AC	4	2163	2170
V2_56	A	0000260C	4	2190	2197
V2_57	A	0000266C	4	2220	2227
V2_58	A	000026CC	4	2246	2253
V2_59	A	0000272C	4	2272	2279
V2_6	A	0000134C	4	834	841
V2_60	A	0000278C	4	2298	2305
V2_61	A	000027EC	4	2325	2332
V2_62	A	0000284C	4	2352	2359
V2_63	A	000028AC	4	2379	2386
V2_64	A	0000290C	4	2406	2413
V2_65	A	0000296C	4	2433	2440
V2_66	A	000029CC	4	2460	2467
V2_67	A	00002A2C	4	2489	2496
V2_68	A	00002A8C	4	2515	2522
V2_69	A	00002AEC	4	2541	2548
V2_7	A	000013AC	4	861	868
V2_70	A	00002B4C	4	2567	2574
V2_71	A	00002BAC	4	2594	2601
V2_72	A	00002C0C	4	2621	2628
V2_73	A	00002C6C	4	2648	2655
V2_74	A	00002CCC	4	2675	2682
V2_75	A	00002D2C	4	2702	2709
V2_76	A	00002D8C	4	2729	2736
V2_77	A	00002DEC	4	2763	2770
V2_78	A	00002E4C	4	2789	2796
V2_79	A	00002EAC	4	2815	2822
V2_8	A	0000140C	4	888	895
V2_80	A	00002F0C	4	2841	2848
V2_81	A	00002F6C	4	2868	2875
V2_82	A	00002FCC	4	2895	2902
V2_83	A	0000302C	4	2922	2929
V2_84	A	0000308C	4	2949	2956
V2_85	A	000030EC	4	2979	2986
V2_86	A	0000314C	4	3005	3012
V2_87	A	000031AC	4	3031	3038
V2_88	A	0000320C	4	3057	3064
V2_89	A	0000326C	4	3084	3091
V2_9	A	0000146C	4	918	925
V2_90	A	000032CC	4	3111	3118
V2_91	A	0000332C	4	3138	3145
V2_92	A	0000338C	4	3165	3172

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES
V3_32	U	00001D09	1	1538	1548
V3_33	U	00001D69	1	1568	1578
V3_34	U	00001DC9	1	1594	1604
V3_35	U	00001E29	1	1620	1630
V3_36	U	00001E89	1	1646	1656
V3_37	U	00001EE9	1	1673	1683
V3_38	U	00001F49	1	1700	1710
V3_39	U	00001FA9	1	1727	1737
V3_4	U	00001289	1	779	789
V3_40	U	00002009	1	1754	1764
V3_41	U	00002069	1	1784	1794
V3_42	U	000020C9	1	1810	1820
V3_43	U	00002129	1	1836	1846
V3_44	U	00002189	1	1862	1872
V3_45	U	000021E9	1	1889	1899
V3_46	U	00002249	1	1916	1926
V3_47	U	000022A9	1	1943	1953
V3_48	U	00002309	1	1970	1980
V3_49	U	00002369	1	2003	2013
V3_5	U	000012E9	1	806	816
V3_50	U	000023C9	1	2029	2039
V3_51	U	00002429	1	2055	2065
V3_52	U	00002489	1	2081	2091
V3_53	U	000024E9	1	2108	2118
V3_54	U	00002549	1	2135	2145
V3_55	U	000025A9	1	2162	2172
V3_56	U	00002609	1	2189	2199
V3_57	U	00002669	1	2219	2229
V3_58	U	000026C9	1	2245	2255
V3_59	U	00002729	1	2271	2281
V3_6	U	00001349	1	833	843
V3_60	U	00002789	1	2297	2307
V3_61	U	000027E9	1	2324	2334
V3_62	U	00002849	1	2351	2361
V3_63	U	000028A9	1	2378	2388
V3_64	U	00002909	1	2405	2415
V3_65	U	00002969	1	2432	2442
V3_66	U	000029C9	1	2459	2469
V3_67	U	00002A29	1	2488	2498
V3_68	U	00002A89	1	2514	2524
V3_69	U	00002AE9	1	2540	2550
V3_7	U	000013A9	1	860	870
V3_70	U	00002B49	1	2566	2576
V3_71	U	00002BA9	1	2593	2603
V3_72	U	00002C09	1	2620	2630
V3_73	U	00002C69	1	2647	2657
V3_74	U	00002CC9	1	2674	2684
V3_75	U	00002D29	1	2701	2711
V3_76	U	00002D89	1	2728	2738
V3_77	U	00002DE9	1	2762	2772
V3_78	U	00002E49	1	2788	2798
V3_79	U	00002EA9	1	2814	2824
V3_8	U	00001409	1	887	897
V3_80	U	00002F09	1	2840	2850
V3_81	U	00002F69	1	2867	2877
V3_82	U	00002FC9	1	2894	2904

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES
V3_83	U	00003029	1	2921	2931
V3_84	U	00003089	1	2948	2958
V3_85	U	000030E9	1	2978	2988
V3_86	U	00003149	1	3004	3014
V3_87	U	000031A9	1	3030	3040
V3_88	U	00003209	1	3056	3066
V3_89	U	00003269	1	3083	3093
V3_9	U	00001469	1	917	927
V3_90	U	000032C9	1	3110	3120
V3_91	U	00003329	1	3137	3147
V3_92	U	00003389	1	3164	3174
V3_93	U	000033E9	1	3191	3201
V3_94	U	00003449	1	3218	3228
V3_95	U	000034A9	1	3247	3257
V3_96	U	00003509	1	3273	3283
V3_97	U	00003569	1	3299	3309
V3_98	U	000035C9	1	3325	3335
V3_99	U	00003629	1	3352	3362
V4	U	00000004	1	3675	263 282 288 294
V5	U	00000005	1	3676	
V6	U	00000006	1	3677	264 295
V7	U	00000007	1	3678	
V8	U	00000008	1	3679	
V9	U	00000009	1	3680	
X0001	U	000002C8	1	193	181 194
X1	F	00001180	4	707	696
X10	F	000014E0	4	949	938
X100	F	000036A0	4	3385	3374
X101	F	00003700	4	3412	3401
X102	F	00003760	4	3439	3428
X103	F	000037C0	4	3466	3455
X104	F	00003820	4	3493	3482
X11	F	00001540	4	975	964
X12	F	000015A0	4	1001	990
X13	F	00001600	4	1028	1017
X14	F	00001660	4	1055	1044
X15	F	000016C0	4	1082	1071
X16	F	00001720	4	1109	1098
X17	F	00001780	4	1139	1128
X18	F	000017E0	4	1165	1154
X19	F	00001840	4	1191	1180
X2	F	000011E0	4	733	722
X20	F	000018A0	4	1217	1206
X21	F	00001900	4	1244	1233
X22	F	00001960	4	1271	1260
X23	F	000019C0	4	1298	1287
X24	F	00001A20	4	1325	1314
X25	F	00001A80	4	1358	1347
X26	F	00001AE0	4	1384	1373
X27	F	00001B40	4	1410	1399
X28	F	00001BA0	4	1436	1425
X29	F	00001C00	4	1463	1452
X3	F	00001240	4	759	748
X30	F	00001C60	4	1490	1479
X31	F	00001CC0	4	1517	1506
X32	F	00001D20	4	1544	1533

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES
X33	F	00001D80	4	1574	1563
X34	F	00001DE0	4	1600	1589
X35	F	00001E40	4	1626	1615
X36	F	00001EA0	4	1652	1641
X37	F	00001F00	4	1679	1668
X38	F	00001F60	4	1706	1695
X39	F	00001FC0	4	1733	1722
X4	F	000012A0	4	785	774
X40	F	00002020	4	1760	1749
X41	F	00002080	4	1790	1779
X42	F	000020E0	4	1816	1805
X43	F	00002140	4	1842	1831
X44	F	000021A0	4	1868	1857
X45	F	00002200	4	1895	1884
X46	F	00002260	4	1922	1911
X47	F	000022C0	4	1949	1938
X48	F	00002320	4	1976	1965
X49	F	00002380	4	2009	1998
X5	F	00001300	4	812	801
X50	F	000023E0	4	2035	2024
X51	F	00002440	4	2061	2050
X52	F	000024A0	4	2087	2076
X53	F	00002500	4	2114	2103
X54	F	00002560	4	2141	2130
X55	F	000025C0	4	2168	2157
X56	F	00002620	4	2195	2184
X57	F	00002680	4	2225	2214
X58	F	000026E0	4	2251	2240
X59	F	00002740	4	2277	2266
X6	F	00001360	4	839	828
X60	F	000027A0	4	2303	2292
X61	F	00002800	4	2330	2319
X62	F	00002860	4	2357	2346
X63	F	000028C0	4	2384	2373
X64	F	00002920	4	2411	2400
X65	F	00002980	4	2438	2427
X66	F	000029E0	4	2465	2454
X67	F	00002A40	4	2494	2483
X68	F	00002AA0	4	2520	2509
X69	F	00002B00	4	2546	2535
X7	F	000013C0	4	866	855
X70	F	00002B60	4	2572	2561
X71	F	00002BC0	4	2599	2588
X72	F	00002C20	4	2626	2615
X73	F	00002C80	4	2653	2642
X74	F	00002CE0	4	2680	2669
X75	F	00002D40	4	2707	2696
X76	F	00002DA0	4	2734	2723
X77	F	00002E00	4	2768	2757
X78	F	00002E60	4	2794	2783
X79	F	00002EC0	4	2820	2809
X8	F	00001420	4	893	882
X80	F	00002F20	4	2846	2835
X81	F	00002F80	4	2873	2862
X82	F	00002FE0	4	2900	2889
X83	F	00003040	4	2927	2916

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES
X84	F	000030A0	4	2954	2943
X85	F	00003100	4	2984	2973
X86	F	00003160	4	3010	2999
X87	F	000031C0	4	3036	3025
X88	F	00003220	4	3062	3051
X89	F	00003280	4	3089	3078
X9	F	00001480	4	923	912
X90	F	000032E0	4	3116	3105
X91	F	00003340	4	3143	3132
X92	F	000033A0	4	3170	3159
X93	F	00003400	4	3197	3186
X94	F	00003460	4	3224	3213
X95	F	000034C0	4	3253	3242
X96	F	00003520	4	3279	3268
X97	F	00003580	4	3305	3294
X98	F	000035E0	4	3331	3320
X99	F	00003640	4	3358	3347
XC0001	U	000002F0	1	207	199
XC001	U	000003B4	1	297	283
XCEXT	F	000003A4	4	292	276
XCHECK	U	0000032E	1	248	231
XCLONG	F	00000394	4	286	274
XCPLINE	C	00001060	13	546	557
XCPLNG	U	0000005F	1	557	334
XCPM4	C	000010A0	2	551	317
XCPM5	C	000010AC	2	553	324
XCPNAME	C	0000108F	8	549	310
XCPSCALE	C	000010BB	3	555	331
XCPTNUM	C	0000106D	3	547	308
XCR15	F	00000478	8	344	333
XCRESULT	X	00000458	16	342	282
XCSHORT	F	00000384	4	280	272
XCV1	X	00000468	16	343	298
ZVE6TST	J	00000000	14872	119	122
=A(E6TESTS)	A	00000650	4	491	214
=AL2(L' MSGMSG)	R	0000066A	2	498	440
=F' 0'	F	00000654	4	492	263
=F' 1'	F	00000664	4	496	390
=F' 128'	F	0000064C	4	490	198
=F' 2'	F	00000658	4	493	271
=F' 3'	F	0000065C	4	494	273
=F' 4'	F	00000660	4	495	275
=H' 0'	H	00000668	2	497	435

MACRO DEFN REFERENCES

FCHECK	71	180
PTTABLE	653	3512
VRR_B	610	693 719 745 771 798 825 852 879 909 935 961 987 1014 1041 1068 1095 1125 1151 1177 1203 1230 1257 1284 1311 1344 1370 1396 1422 1449 1476 1503 1530 1560 1586 1612 1638 1665 1692 1719 1746 1776 1802 1828 1854 1881 1908 1935 1962 1995 2021 2047 2073 2100 2127 2154 2181 2211 2237 2263 2289 2316 2343 2370 2397 2424 2451 2480 2506 2532 2558 2585 2612 2639 2666 2693 2720 2754 2780 2806 2832 2859 2886 2913 2940 2970 2996 3022 3048 3075 3102 3129 3156 3183 3210 3239 3265 3291 3317 3344 3371 3398 3425 3452 3479

DESC	SYMBOL	SIZE	POS	ADDR
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Entry: 0

Image	IMAGE	14872	0000-3A17	0000-3A17
Region		14872	0000-3A17	0000-3A17
CSECT	ZVE6TST	14872	0000-3A17	0000-3A17

STMT	FILE NAME
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1	/home/tn529/sharedvfp/tests/zvector-e6-17-VSCHP.asm
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** NO ERRORS FOUND **
